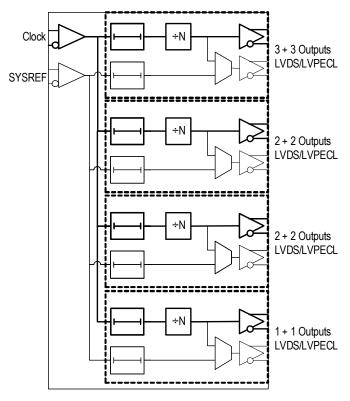


### **Description**

The 8V79S683 is a fully integrated, clock and SYSREF signal fanout buffer for JESD204B/C applications. It is designed as a high-performance clock and converter synchronization solution for wireless base station radio equipment boards with JESD204B/C subclass 0, 1, and 2 compliance. The main function of the device is the distribution and fanout of high-frequency clocks and low-frequency system reference signals generated by a JESB204B clock generator such as the IDT 8V19N490, extending its fanout capabilities and providing additional phase-delay. The 8V79S683 is optimized to deliver very low phase noise clocks and precise, phase-adjustable SYSREF synchronization signals. Low-skew outputs, low device-to-device skew characteristics and fast output rise/fall times help the system design to achieve deterministic clock and SYSREF phase relationship across devices.

The device distributes the input clock (CLK) and JESD204B SYSREF signals (REF) to four fanout channels. Input clock signals can be frequency divided and are fanned-out to multiple clock (QCLK\_y) and SYSREF (QREF\_r) outputs. Configurable phase-delay circuits are available for both clock and SYSREF signals. The propagation delays in all signal paths are fully deterministic to support fixed phase relationships between clock and SYSREF signals within one device. The device facilitates synchronization between frequency dividers within the device and across multiple devices, removing phase ambiguity introduced in dividers between power and configuration cycles.

## **Simplified Block Diagram**



#### **Features**

- Distribution, fanout, phase-delay of clock and SYSREF signals
- Very low output noise floor: -158.8dBc/Hz noise floor (245.76MHz)
- Supports clock frequencies up to 3GHz, including clock output frequencies of 983.04MHz, 491.52MHz, 245.76MHz, and 122.88MHz
- Four output channels with a total of 16 differential outputs
- Each channel contains frequency dividers and clock phase delay circuits
- Phase alignment mode across multiple buffers with any frequency divider setting
- Flexible differential outputs (LVDS/LVPECL/amplitude configurable)
- Configuration through 3-wire SPI interface
- Supply voltage:
  - 3.3V core and signal I/O
  - 1.8V Digital control SPI I/O (3.3V-tolerant inputs)
- 64-VFQFPN package (9 × 9 × 0.85 mm)
- Ambient temperature range: -40°C to +105°C (case)

### **Typical Applications**

- Wireless infrastructure applications: 4G, 5G, and mmWave
- Frequency divider synchronization across multiple devices
- Ideal clock driver for jitter-sensitive ADC and DAC circuits
- Radar, imaging, instrumentation and medical

## **Applicable Standards**

JESD204B/C, subclass 0, 1, and 2



## Features (Cont.)

- 4 output channels with a total of 16 differential outputs, organized in:
  - 8 dedicated clock outputs
  - 8 outputs configurable as SYSREF outputs with individual phase delay stages, or configurable as additional clock outputs
  - Clock outputs are powered-on and enabled at startup
  - QREF\_r (SYSREF) outputs are disabled at startup
- Clock channel contains:
  - frequency dividers:  $\div 1$ ,  $\div 2$ ,  $\div 3$ ,  $\div 4$ ,  $\div 6$ ,  $\div 8$ ,  $\div 12$ ,  $\div 16$ ,  $\div 24$
  - clock phase delay circuits, delay unit is the clock period; 256 steps
- SYSREF: Configurable precision phase delay circuits: 8 steps of 131ps, 262ps, 393ps or 524ps
- Flexible differential outputs:
  - LVDS/LVPECL configurable
  - Amplitude configurable
  - Power-down modes for unused outputs
  - Supports DC and AC coupling
  - QREF\_r (SYSREF) output pre-bias feature to prevent glitches when turning output on or off



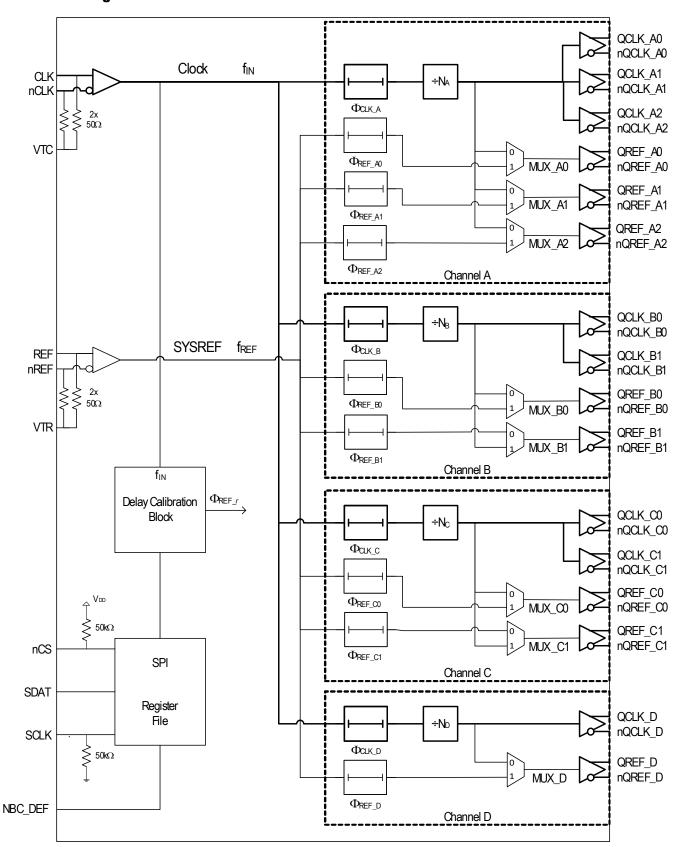
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## **Block Diagram**

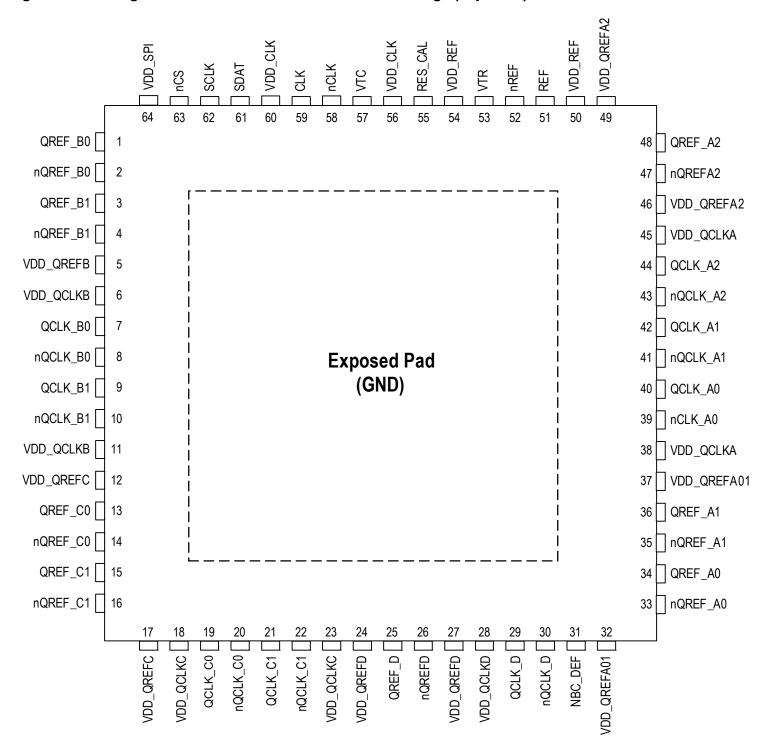
Figure 1: Block Diagram





## **Pin Assignments**

Figure 2: Pin Assignments 9 x 9 x 0.85 mm 64-VFQFPN Package (Top View)





# **Pin Descriptions**

### **Table 1: Pin Descriptions**

| Number    | Name                    | Ty     | pe <sup>a</sup> | Description  |
|-----------|-------------------------|--------|-----------------|--|
| 1,<br>2   | QREF_B0,<br>nQREF_B0    | Output |                 | Differential SYSREF/clock output QREF_B0. LVDS style for SYSREF operation, configurable LVPECL/LVDS style and amplitude for clock operation. |
| 3,<br>4   | QREF_B1,<br>nQREF_B1    | Output |                 | Differential SYSREF/clock output QREF_B1. LVDS style for SYSREF operation, configurable LVPECL/LVDS style and amplitude for clock operation. |
| 5         | V <sub>DD_QREFB</sub>   | Power  |                 | Positive supply voltage (3.3V) for the QREF_B[1:0] outputs.  |
| 6         | V <sub>DD_QCLKB</sub>   | Power  |                 | Positive supply voltage (3.3V) for the QCLK_B[1:0] outputs.  |
| 7,<br>8   | QCLK_B0,<br>nQCLK_B0    | Output |                 | Differential clock output QCLK_B0. Configurable LVPECL/LVDS style and amplitude.   |
| 9,<br>10  | QCLK_B1,<br>nQCLK_B1    | Output |                 | Differential clock output QCLK_B1. Configurable LVPECL/LVDS style and amplitude.   |
| 11        | V <sub>DD_QCLKB</sub>   | Power  |                 | Positive supply voltage (3.3V) for the QCLK_B[1:0] outputs.  |
| 12        | V <sub>DD_QREFC</sub>   | Power  |                 | Positive supply voltage (3.3V) for the QREF_C[1:0] outputs.  |
| 13,<br>14 | QREF_C0,<br>nQREF_C0    | Output |                 | Differential SYSREF/clock output QREF_C0. LVDS style for SYSREF operation, configurable LVPECL/LVDS style and amplitude for clock operation. |
| 15,<br>16 | QREF_C1,<br>nQREF_C1    | Output |                 | Differential SYSREF/clock output QREF_C1. LVDS style for SYSREF operation, configurable LVPECL/LVDS style and amplitude for clock operation. |
| 17        | V <sub>DD_QREFC</sub>   | Power  |                 | Positive supply voltage (3.3V) for the QREF_C[1:0] outputs.  |
| 18        | V <sub>DD_QCLKC</sub>   | Power  |                 | Positive supply voltage (3.3V) for the QCLK_C[1:0] outputs.  |
| 19,<br>20 | QCLK_C0,<br>nQCLK_C0    | Output |                 | Differential clock output QCLK_C0. Configurable LVPECL/LVDS style and amplitude.   |
| 21,<br>22 | QCLK_C1,<br>nQCLK_C1    | Output |                 | Differential clock output QCLK_C1. Configurable LVPECL/LVDS style and amplitude.   |
| 23        | V <sub>DD_QCLKC</sub>   | Power  |                 | Positive supply voltage (3.3V) for the QCLK_C[1:0] outputs.  |
| 24        | V <sub>DD_QREFD</sub>   | Power  |                 | Positive supply voltage (3.3V) for the QREF_D outputs.   |
| 25,<br>26 | QREF_D,<br>nQREF_D      | Output |                 | Differential SYSREF/clock output QREF_D. LVDS style for SYSREF operation, configurable LVPECL/LVDS style and amplitude for clock operation.  |
| 27        | V <sub>DD_QREFD</sub>   | Power  |                 | Positive supply voltage (3.3V) for the QREF_D outputs.   |
| 28        | V <sub>DD_QCLKD</sub>   | Power  |                 | Positive supply voltage (3.3V) for the QCLK_D outputs.   |
| 29,<br>30 | QCLK_D,<br>nQCLK_D      | Output |                 | Differential clock output QCLK_D. Configurable LVPECL/LVDS style and amplitude.  |
| 31        | NBC_DEF                 | Input  | Pullup          | Sets the default (power-up) value of the N <sub>B</sub> and N <sub>C</sub> frequency dividers.   |
| 32        | V <sub>DD_QREFA01</sub> | Power  |                 | Positive supply voltage (3.3V) for the QREF_A[1:0] outputs.  |
| 33,<br>34 | nQREF_A0,<br>QREF_A0    | Output |                 | Differential SYSREF/clock output QREF_A0. LVDS style for SYSREF operation, configurable LVPECL/LVDS style and amplitude for clock operation. |
| 35,<br>36 | nQREF_A1,<br>QREF_A1    | Output |                 | Differential SYSREF/clock output QREF_A1. LVDS style for SYSREF operation, configurable LVPECL/LVDS style and amplitude for clock operation. |



**Table 1: Pin Descriptions (Continued)** 

| Number Name         |                         | Type <sup>a</sup> |    | Description  |
|---------------------|-------------------------|-------------------|----|--|
| 37                  | V <sub>DD_QREFA01</sub> | Power             |    | Positive supply voltage (3.3V) for the QREF_A[1:0] outputs.  |
| 38                  | V <sub>DD_QCLKA</sub>   | Power             |    | Positive supply voltage (3.3V) for the QCLK_A[2:0] outputs.  |
| 39,<br>40           | nQCLK_A0,<br>QCLK_A0    | Output            |    | Differential clock output QCLK_A0. Configurable LVPECL/LVDS style and amplitude.   |
| 41,<br>42           | nQCLK_A1,<br>QCLK_A1    | Output            |    | Differential clock output QCLK_A1. Configurable LVPECL/LVDS style and amplitude.   |
| 43,<br>44           | nQCLK_A2,<br>QCLK_A2    | Output            |    | Differential clock output QCLK_A2. Configurable LVPECL/LVDS style and amplitude.   |
| 45                  | V <sub>DD_QCLKA</sub>   | Power             |    | Positive supply voltage (3.3V) for the QCLK_A[2:0] outputs.  |
| 46                  | V <sub>DD_QREFA2</sub>  | Power             |    | Positive supply voltage (3.3V) for the QREF_A2 output.   |
| 47,<br>48           | nQREF_A2,<br>QREF_A2    | Output            |    | Differential SYSREF/clock output QREF_A2. LVDS style for SYSREF operation, configurable LVPECL/LVDS style and amplitude for clock operation.   |
| 49                  | V <sub>DD_QREFA2</sub>  | Power             |    | Positive supply voltage (3.3V) for the QREF_A2 output.   |
| 50                  | V <sub>DD_REF</sub>     | Power             |    | Positive supply voltage (3.3V) for the differential SYSREF input REF, nREF   |
| 51, 52              | REF, nREF               | Input             |    | SYSREF inverting and non-inverting differential input. Compatible with LVPECL and LVDS signals. REF and nREF are internally $50\Omega$ terminated to the VTR pin   |
| 53                  | VTR                     | -                 |    | Internal termination for the differential clock input REF, nREF. Both REF and nREF inputs are internally terminated $50\Omega$ to this pin. See input termination information in Section "Application Information".    |
| 54                  | $V_{DD\_REF}$           | Power             |    | Positive supply voltage (3.3V) for the differential SYSREF input REF, nREF   |
| 55                  | RES_CAL                 | Analog            |    | Connect a 2.8 kΩ (1%) resistor to GND for output current calibration.  |
| 56                  | V <sub>DD_CLK</sub>     | Power             |    | Positive supply voltage (3.3V) for the differential device clock input CLK, nCLK.  |
| 57                  | VTC                     | -                 |    | Internal termination for the differential clock input CLK, nCLK. Both CLK and nCLK inputs are internally $50\Omega$ terminated to the VTR pin. See input termination information in Section "Application Information". |
| 58, 59              | nCLK, CLK               | Input             |    | Device clock inverting and non-inverting differential clock input. Compatible with LVPECL and LVDS signals. CLK and nCLK are internally terminated to VTC through $50\Omega$ .   |
| 60                  | V <sub>DD_CLK</sub>     | Power             |    | Positive supply voltage (3.3V) for the differential device clock input CLK, nCLK.  |
| 61                  | SDAT                    | Input/<br>Output  |    | Serial Control Port SPI Mode Data Input and Output. 1.8V LVCMOS/LVTTL interface levels. 3.3V tolerant when input.  |
| 62                  | SCLK                    | Input             | PD | Serial Control Port SPI Mode Clock Input. 1.8V LVCMOS/LVTTL interface levels. 3.3V-tolerant when input.  |
| 63                  | nCS                     | Input             | PU | Serial Control Port SPI Chip Select Input. 1.8V LVCMOS/LVTTL interface levels and 3.3V tolerant.   |
| 64                  | V <sub>DD_SPI</sub>     | Power             |    | Positive supply voltage (3.3V) for the SPI interface.  |
| Exposed<br>Pad (EP) | GND                     | Power             |    | Ground supply voltage (GND) and ground return path. Connect to board GND (0V).   |

a. Internal pull-up (PU) and pull-down (PD) resistors are indicated in parentheses. See Table 25 for values.



### **Principles of Operation**

#### **Overview**

The 8V79S683 is a JESD204B/C Fanout Buffer with Configurable Phase Delay. The device supports the division, phase-delay and distribution of high-frequency clocks (input: CLK, nCLK) and the fanout and phase-delay of low-frequency synchronization (SYSREF) signals (input: REF/nREF). Clock and SYSREF signal paths are independent and are organized in channels, with each channel consisting of several clock and SYSREF outputs. Outputs are configurable with support for LVPECL, LVDS and four amplitude settings. Individual channels and unused circuit blocks support a powered-down state for reduced power consumption operation. The register map, accessible through a SPI interface with read-back capability controls the main device settings.

### **Signal Flow**

The device offers four channels with the names A, B, C, and D. Each channel supports individual frequency-division, phase-delay and fan-out functions of the input clock to a total of eight QCLK\_y clock outputs; each channel also distributes the SYSREF input signal to multiple QREF\_r outputs with individual per-output phase delay capability.

The central clock distribution ensures low skew clock outputs within each channel; outputs are synchronous across channels (independent on the divider setting) on the incident rising clock edge for all outputs with equal phase delay settings.

SYSREF output are synchronous with each other for equal phase-delay settings. QCLK\_y and QREF\_r outputs will be phase-locked to each other if the CLK and REF inputs are phase-locked. The phase-delay capability in each signal path can be used to establish repeatable and deterministic clock to SYSREF phase relationships at the outputs.

The CLK and QREF signal paths are optimized for channel isolation. allowing high-speed clocks of 983.04MHz, 1474.56MHz or 1966.08MHz (up to 3GHz) and lower-speed SYSREF signals at e.g. 7.68MHz or 9.6MHz with a minimum of signal crosstalk and spurious signals.

#### **Clock Channel Divider**

Each of the four independent frequency dividers  $N_A$ - $N_D$  can be individually set to the divider values  $\div 1$ ,  $\div 2$ ,  $\div 3$ ,  $\div 4$ ,  $\div 6$ ,  $\div 8$ ,  $\div 12$ ,  $\div 16$  and  $\div 24$ . The dividers are synchronous and have an equal propagation delay on the incident edge. See Table 2 for the supported frequency divider settings. The default (power-up) divider value for channel A and D is  $\div 1$ , the default divider value for channel B and C is set by the state of pin 31 (NBC\_DEF).

Table 2: N<sub>A-D</sub> Frequency Divider Settings

| N <sub>A-D</sub> | Clock Divider                         |
|------------------|---------------------------------------|
| 0000             | ÷1<br>Divider bypass and powered down |
| 0001             | ÷2                                    |
| 0010             | ÷3                                    |
| 0011             | ÷4                                    |
| 0100             | ÷6                                    |
| 0101             | ÷8                                    |
| 0110             | ÷12                                   |
| 0111             | ÷16                                   |
| 1000             | ÷24                                   |

**Table 3: Frequency Divider Default Settings** 

| Divider                         | Default Clock Divider |                          |  |
|---------------------------------|-----------------------|--------------------------|--|
| Dividei                         | NBC_DEF = 0           | NBC_DEF = 1 <sup>a</sup> |  |
| N <sub>A</sub> , N <sub>D</sub> | ÷1                    |                          |  |
| N <sub>B</sub> , N <sub>C</sub> | ÷3 ÷4                 |                          |  |

a. NBC\_DEF can be left open (reads logic 1)



#### **Phase Delay**

Output phase delay is independently supported on each clock channel and each SYSREF output. The delay unit of the clock channel phase-delay circuits  $\Phi_{CLK}$  x is a function of the frequency  $f_{IN}$  applied to CLK input:  $1 \div f_{IN}$ .

The delay unit of the SYSREF phase-delay circuits  $\Phi_{REF\_r}$  is a function of an internal oscillator frequency  $f_{DCO}$  and the DLC multiplier setting. The oscillator is fully self-contained and located in delay calibration block (DCB). At startup, this oscillator is calibrated with the input frequency  $f_{IN}$  as reference. After the calibration, the oscillator is turned-off to save power and to eliminate noise. See Table 4 for details on the delay unit, number of available steps and the delay range.

**Table 4: Delay Circuit Characteristics** 

| Delay Circuit                 | Unit   | Steps | Range  |
|-------------------------------|--|-------|--|
| Clock channel &               | 1 ÷ f <sub>IN</sub>  | 256   | 256 ÷ f <sub>IN</sub> <sup>a</sup>   |
| Clock channel $\Phi_{CLK\_x}$ | 1.017ns at f <sub>IN</sub> = 983.04MHz                               | 250   | 0 to 259.3ns at f <sub>IN</sub> = 983.04MHz  |
|                               | T <sub>DCB</sub> <sup>b</sup>  |       | 07 * T <sub>DCB</sub> <sup>c</sup>   |
| SYSREF $\Phi_{REF\_r}$        | DLC = 0: 131ps<br>DLC = 1: 262ps<br>DLC = 2: 393ps<br>DLC = 3: 524ps | 8     | DLC = 0: 0 to 0.917ns<br>DLC = 1: 0 to 1.834ns<br>DLC = 2: 0 to 2.751ns<br>DLC = 3: 0 to 3.668ns |

- a. At f<sub>IN</sub> = 983.04MHz, the clock channel delay range is equal to 260.416ns and encompasses 32 periods of a 122.88MHz clock signal.
- b.  $T_{DCB} \sim DLC \div (8 \cdot f_{DCO})$ .  $f_{DCO} = 983.04 MHz$ . DLC = 1, 2, 3 or 4.
- c. SYSREF phase delay supports  $\geq$ 8 delay stops within one input reference period for  $f_{IN}$  = 254.76MHz to  $f_{IN}$  = 983.04MHz.

### **Delay Calibration Block (DCB)**

The DCB sets the SYSREF delay unit by providing a reference signal to the QREF\_r delay circuits. Figure 3 shows the functional diagram. The DCB requires configuration and calibration. Verification of the calibration is optional.

**Description.** The DCB consists of an internal DCO running at  $f_{DCO}$  = 983.04±20MHz, three frequency dividers  $P_{DCB}$ ,  $M_{DCB}$  and  $N_{DCB}$  and a digital hold circuit. The DCB input frequency is the device input frequency  $f_{IN}$  at the differential CLK, nCLK input. The input frequency acts as a reference to lock the oscillator to a stable and known frequency.

The output of the DCB is the effective delay unit  $T_{DCB}$  which is approx. one eighth of the oscillator period multiplied by the DLC multiplier. The DLC multiplier extends the delay unit by a factor of 1, 2, 3 or 4. For instance, at a DCO frequency of 983.04MHz, DLC = 1 sets the SYSREF delay unit to 131ps; DLC = 2 sets the delay unit to 262ps, etc.

**Configuration.** Select a desired delay unit and corresponding DLC multiplier from Table 5. DLC[1:0] also sets the N<sub>DCB</sub> divider. Then, find a P<sub>DCB</sub> and M<sub>DCB</sub> divider configuration to locate the oscillator frequency into the range of  $f_{DCO}$  = 983.04MHz according to the formula in Figure 3. The DCO lock condition is  $f_1$  =  $f_2$  while both  $f_1$  and  $f_2$  must be lower than 200MHz. For instance, if  $f_{IN}$  = 245.76MHz and the smallest possible SYSREF delay unit is desired, set DLC = 1 (DLC[1:0] = 00; also sets N<sub>DCB</sub> =  $\div$ 1). Then, set P<sub>DCB</sub> =  $\div$ 24 and M<sub>DCB</sub> =  $\div$ 96. As a result,  $f_1$  =  $f_2$  = 10.24MHz,  $f_{DCO}$  = 983.04MHz. This example configuration results in a delay unit of measured: 131ps. Figure 6 shows more configuration examples.

**Calibration.** Calibration requires a valid DCB configuration with the DCO locking to an input frequency. Setting DCB\_CAL = 1 starts an automatic calibration. At the end, the DCB\_CAL bit will clear, the delay unit value is stored digitally and the DCO, P<sub>DCB</sub>, M<sub>DCB</sub> and N<sub>DCB</sub> frequency dividers turn off. The QREF\_r delay circuits now use the stored constant delay unit. The delay unit remains digitally stored until the next power cycle. The DCB calibration must run once as part of the device startup procedure and must be re-run after each input frequency or DCB configuration change.

**Verification.** Verify a successful calibration by reading the DAC\_CODE value.  $0 < DAC_CODE < 32767$  indicates a successful calibration. If DAC\_CODE = 0 or DAC\_CODE = 32767, the DCB calibration should be re-run with an alternative  $P_{DCB}$ ,  $M_{DCB}$  setting while maintaining the desired  $M_{DCB} \cdot N_{DCB}/P_{DCB}$  ratio for locking the DCO to the input frequency.



Figure 3: DCB Functional Diagram

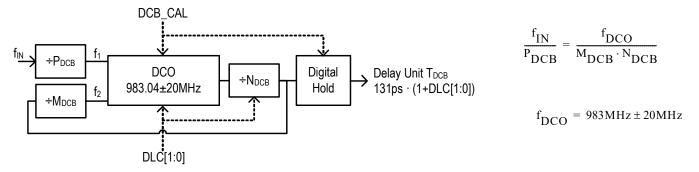


Table 5: DCB Delay Unit at  $f_{DCO}$  = 983.04MHz

| T <sub>DCB</sub><br>Delay Unit (ps) |                  | N             |                  |
|-------------------------------------|------------------|---------------|------------------|
|                                     | DLC[1:0] Setting | Numeric Value | N <sub>DCB</sub> |
| 131                                 | 00               | 1             | 1                |
| 262                                 | 01               | 2             | 2                |
| 393                                 | 10               | 3             | 3                |
| 524                                 | 11               | 4             | 4                |

Table 6: DCB Divider Configuration Examples<sup>a</sup>

| f <sub>IN</sub> (MHz) | T <sub>DCB</sub><br>Delay Unit in ps | DLC | P <sub>DCB</sub> | M <sub>DCB</sub> |
|-----------------------|--------------------------------------|-----|------------------|------------------|
|                       | 131                                  | 1   | 24               | 96               |
| 245.76                | 262                                  | 2   | 24               | 48               |
| 245.70                | 393                                  | 3   | 24               | 32               |
|                       | 524                                  | 4   | 24               | 24               |
|                       | 131                                  | 1   | 48               | 96               |
| 491.52                | 262                                  | 2   | 48               | 48               |
| 491.52                | 393                                  | 3   | 48               | 32               |
|                       | 524                                  | 4   | 48               | 24               |
|                       | 131                                  | 1   | 96               | 96               |
| 983.04                | 262                                  | 2   | 96               | 48               |
| 903.04                | 393                                  | 3   | 96               | 32               |
|                       | 524                                  | 4   | 96               | 24               |

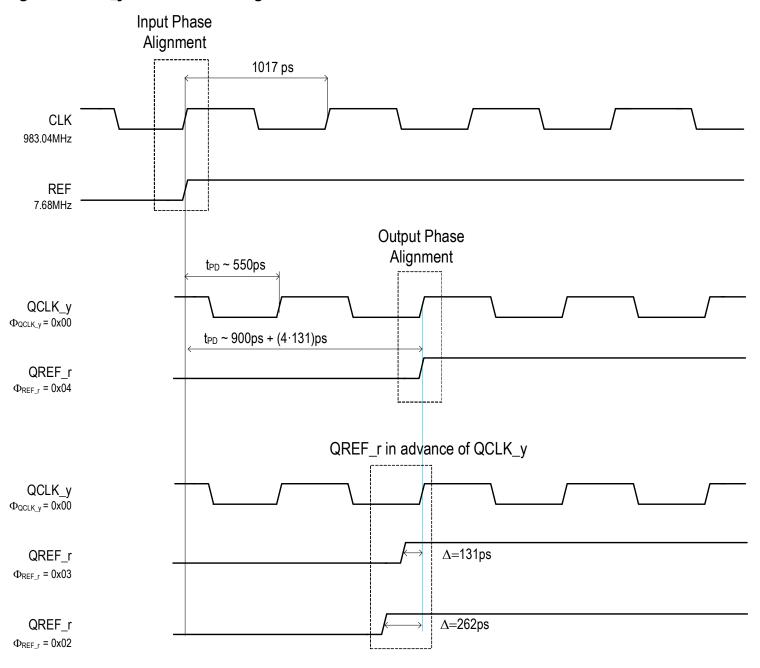
a.  $f_{DCO} = 983.04MHz$ 



### QCLK\_y to SYSREF Phase Alignment

Single Device: To achieve an output phase alignment between the QCLK\_y clock and the QREF\_rSYSREF outputs, the CLK and REF input signals must be phase aligned or have a known, deterministic phase relationship. Figure 4 shows an example output phase alignment for aligned clock and SYREF inputs. The closest (smallest phase error) output alignment is achieved by setting the clock phase delay register  $\Phi_{QCLK_Y}$  to 0x00 (clock) and the SYSREF phase delay register  $\Phi_{QCLK_Y}$  to 0x04. With a SYSREF phase delay setting of 0x03 or less, the QREF\_r output phase is in advance of the QCLK\_y phase, which is applicable in JESD204B/C application. Phase delay settings and propagation delays are independent on the clock and SYSREF frequencies. Table 7 shows recommended phase delay setting several device configurations.

Figure 4: QCLK\_y to QREF Phase Alignment





### Table 7: Recommended Delay Settings for Closest Clock-SYSREF Output Phase Alignment<sup>a</sup>

| Divider Configuration | ΦCLK_y | Φ <b>REF</b> _r |
|-----------------------|--------|-----------------|
| N = ÷1                | 0x00   | 0x04            |

a. QCLK\_y and QREF outputs are aligned on the incident edge.

#### QCLK\_y and QREF\_r Phase Alignment Across Multiple 8V79S683 Devices

The device architecture supports phase aligned QCLK\_y and QREF\_r output signals across multiple 8V79S683NLGI devices. For applications that use the frequency dividers of  $\div 2$ ,  $\div 3$ ,  $\div 4$ ,  $\div 6$ ,  $\div 8$ ,  $\div 12$ ,  $\div 16$  or  $\div 24$ , or any combination of these dividers, all devices participating in the output phase alignment must go through a specific alignment procedure at device startup

#### **Pre-conditions**

- Each 8V79S683NLGI device must be driven by a clock device that keeps clock and SYSREF signals aligned at the CLK and REF inputs (see setup and hold time specification)
- The frequency on the REF input must be smaller than any QCLK y output frequency
- A valid input frequency must be applied to the CLK input, for instance 491.52MHz

#### **Alignment Method**

- Phase alignment is achieved by driving the all REF inputs with a rising edge signal at the same time with respect to the CLK input signal
- During the alignment process, the output period of the divided clock signal (on QCLK\_y outputs) will have longer periods until output alignment is achieved
  - Example: input CLK frequency is 491.52MHz, output divider is ÷4, output frequency is 122.88MHz. During the alignment procedure started by REF, the QCLK\_y output period changes from 8.138ns to 10.172ns for multiple cycles. The device facilitates the period of the input signal (2.034ns) to "stretch" the output period: 8.138 ns + 2.034 ns = 10.172 ns

#### **Alianment Procedure**

- Set the MD ALIGN Φ bit to enable the alignment procedure
  - wait for ≥5 µs before applying a signal to the REF input
- Apply an alignment signal (rising edge) to the REF input
  - place the rising edge REF signal before the rising edge of the CLK signal that is shared between all participating buffers
  - REF to CLK setup and hold time specification must be met
  - a single REF rising edge is sufficient for starting the alignment
- Output behavior during alignment:
  - QCLK\_y outputs in ÷1 divider mode work normally as expected without cycle slips or period increases
  - QCLK\_y outputs in ÷2, ÷3, ÷4, ÷6, ÷8, ÷12, ÷16 or ÷24 divider mode expose longer periods as described above
  - REF outputs always buffer out the REF input signal (when QREF r outputs are powered on and are enabled)

#### Result

- The procedure aligns the output phases (rising incident edge) of all QCLK\_y output signals across participating buffers. This includes the
  output phases of the frequency-divided clock signals and the outputs divided by 1
- The input to output delay is the same across all participating buffer devices (measured on the incident edge)
- The alignment procedure has a maximum duration of  $48 \times (1 \div f_{IN})$
- After alignment is achieved, the device auto-clears the MD\_ALIGN\_Φ register bit

The alignment procedure can be repeated at any time after setting the MD\_ALIGN\_Φ bit.



Table 8: MD\_ALIGN\_Ф Multi-Device Phase Alignment Function Table

| MD_ALIGN_Ф  | Operation   | Comment   |  |
|-------------|---|---|--|
| 0 (default) | Multi-buffer phase alignment is disabled                                      | SYSREF signals at the REF input are buffered out to the SYSREF outputs when output buffers are enabled.   |  |
| 1           | A rising edge at the REF input will start an output phase alignment procedure | Requires a valid clock signal at the CLK input. REF to CLK setup and hold time specifications have to be met. This bit auto-clears after alignment is achieved. |  |

### **Differential Outputs**

#### **Table 9: Output Features**

| Output                                    | Style  | Amplitude <sup>a</sup> | Disable | Power Down | DC Bias          | Termination                        |
|---|--------|------------------------|---------|------------|------------------|------------------------------------|
| QCLK_y <sup>b</sup> , QREF_r <sup>c</sup> | LVPECL | 350-1000mV<br>3 steps  | Yes     | Yes        | -                | $50\Omega$ to $V_T^d$              |
| (Clock)                                   | LVDS   | 350, 750mV<br>2 steps  |         |            |                  | 100Ω differential <sup>e f</sup>   |
| QREF_r                                    | LVPECL | 350-1000mV<br>3 steps  | Yes     | Yes        | -                | 50Ω to V <sub>T</sub> <sup>d</sup> |
| (SYSREF)                                  | LVDS   | 350, 750mV<br>2 steps  | 163     | 166        | Yes <sup>g</sup> | 100Ω differential <sup>e f</sup>   |

- a. Amplitudes are measured single-ended. Differential amplitudes supported are 700mV, 1500mV and 2000mV.
- b. y = A0, A1, A2, B0, B1, C0, C1 and D.
- c. r = A0, A1, A2, B0, B1, C0, C1 and D.
- d.  $V_T = V_{DD\ V} 1.6V$  (350mV amplitude setting),  $V_{DD\_V} 2.0V$  (750mV amplitude setting),  $V_{DD\_V} 2.25V$  (1000mV amplitude setting).
- e. AC coupling and DC coupling supported.
- f. See Application Information for output termination information.
- g. In JESD204B/C applications, it is recommended to use QREF\_r (SYSREF) outputs configured to LVDS and 350mV amplitude. AC-coupling and DC-coupling is supported.



Table 10: Individual Clock Output (QCLK\_y) Settings<sup>a</sup>

| PD | STYLE | EN | A[1:0] | Output Power | Termination <sup>b</sup>                          | State                | Amplitude (mV) |
|----|-------|----|--------|--------------|---|----------------------|----------------|
| 1  | Х     | Χ  | Χ      | Off          | $100\Omega$ differential (LVDS) or no termination | Off                  | Х              |
|    |       | 0  | XX     |              |   | Disable <sup>c</sup> | Х              |
|    | 0     | 1  | 00     |              | $100\Omega$ differential (LVDS)                   | Enable               | 350            |
|    |       | '  | 01     |              |   |                      | 750            |
| 0  |       | 0  | XX     | On           | $50\Omega$ to V $_{\rm T}$ (LVPECL)               | Disable              | Х              |
| U  |       | 1  | 00     |              |   | Enable               | 350            |
|    | 1     |    | 01     |              |   |                      | 750            |
|    |       | I  | 10     |              |   |                      | 1000           |
|    |       |    | 11     |              |   |                      | 1000           |

- a. Applicable to clock outputs: QCLK\_y and QREF\_r outputs in clock mode (MUX\_r = 0).
- b. See Application Information for output termination information.
- c. Differential output is disabled in static low state: QCLK\_y = L, nQCLK\_y = H.

Table 11: Individual SYSREF Output (QREF\_r) Settings<sup>a</sup>

| PD | STYLE | Enable | A[1:0]              | BIAS                     | Output<br>Power | Termination <sup>b</sup>              | State                    | Amplitude (mV) |     |
|----|-------|--------|---------------------|--------------------------|-----------------|---------------------------------------|--------------------------|----------------|-----|
| 1  | Х     | Х      | Х                   | Х                        | Off             | 100Ω differential or no termination   | Off                      | Х              |     |
|    |       | 0      | XX                  | 0                        |                 |                                       | Disable <sup>c</sup>     | Х              |     |
|    | 0     |        | 00 0<br>1 01 0<br>1 | 1000 differential (LVDS) |                 | Enabled                               | 350                      |                |     |
|    |       | 1 1    |                     | 01                       | 0               |                                       | 100Ω differential (LVDS) | See Table 12   | 750 |
|    |       |        |                     | 1                        |                 |                                       | Enabled                  | 750            |     |
| 0  |       | 0      | XX                  |                          | On              |                                       | Disable                  | Х              |     |
|    |       |        | 00                  |                          |                 |                                       |                          | 350            |     |
|    | 1     | 4      | 01                  | 0                        |                 | $50\Omega$ to V <sub>T</sub> (LVPECL) | Enable                   | 750            |     |
|    |       | 1      | 10                  |                          |                 |                                       |                          | 1000           |     |
|    |       |        | 11                  |                          |                 |                                       |                          | 1000           |     |

- a. Applicable QREF\_r outputs when configured as SYSREF output (MUX\_r = 1).
- b. See Application Information for output termination information.
- c. Differential output is disabled in static low state: QCLK\_y = L, nQCLK\_y = H.



Table 12: QREF\_r Setting for JESD204B/C Applications

| BIAS_TYPE | BIAS_r | Initial   | Active Rising Edge on the REF Input                            | SYSREF Completed  | Application       |
|-----------|--------|---|--|---|-------------------|
| 0         | 0      | Static Low<br>(QREF = L, nQREF_r = H)               | Start switching for the<br>number of received<br>SYSREF pulses | Released to static low (QREF = L, nQREF_r = H)                        | QREF_r DC coupled |
|           | 1      | Statio  |  |   |                   |
| 1         | 0      | Static LVDS crosspoint level (QREF = nQREF_r = VOS) | Start switching for the<br>number of received<br>SYSREF pulses | Released to static LVDS<br>crosspoint level<br>(QREF = nQREF_r = VOS) | QREF_r AC coupled |
|           | 1      | Static LVDS cr                                      |  |   |                   |

### **Device Startup, Reset, and Synchronization**

At startup, an internal POR (power-on reset) resets the device and sets all register bits to its default value. The default divider value of the NB and NC frequency dividers is set by the state of the NBC\_DEF pin. After internal POR, the device will initialize internal circuits and for 2ms before it accepts an external clock signal at the CLK input (the CLK input is internally turned off during that time).

In the default configuration the QCLK\_y outputs are enabled, QREF outputs are disabled at startup.

Recommended configuration sequence (in order):

- 1. (Optional) set the value of the CPOL register bit to define the SPI read mode, so that SPI settings can be validated by subsequent SPI read accesses.
- 2. Verify the completion of internal power-up by reading the ST\_READY status bit in register 0x6E, bit D1. ST\_READY is set to 1 by the device at the end of the internal power-up procedure. Continue the device startup once ST\_READY is set to 1.
- 3. Configure the channel circuits and the outputs to the desired values and configure the DCB:
  - For synchronization between multiple devices: See section QCLK\_y and QREF\_r Phase Alignment Across Multiple 8V79S683 Devices.

    After the MD\_ALIGN\_Φ bit is set, the device will wait for a REF rising edge input to start the phase alignment. After alignment is completed, the MD\_ALIGN\_Φ bit will auto-clear. The multi-device alignment requires a valid clock signal to be applied to the CLK input.
  - Output source MUX\_r, output divider N<sub>A-D</sub>, clock delay Φ<sub>A-D</sub>; MUX-output style, amplitude and power down mode for QCLK\_y and QREF\_r outputs
  - (Optional) the global BIAS\_TYPE bit and BIAS\_r for each QREF\_r in preparation for JESD204B/C SYSREF operation
  - Phase delay for Φ<sub>REF</sub> <sub>r</sub> values for the QREF\_r outputs
  - Setup the DCB settings DLC, P<sub>DCB</sub> and M<sub>DCB</sub> as described in the paragraph Configuration, see Delay Calibration Block (DCB)
- 4. If not already applied: apply a valid input frequency to CLK. Set the PB\_CAL bit and the DCB\_CAL bit to start the calibration of the precision bias current circuit and the DCB calibration. Both bits will auto-clear. See paragraph Configuration in section Delay Calibration Block (DCB).
  - (Optional): verify the success of the DCB calibration by reading the DAC\_CODE value. See paragraph Verification in section Delay Calibration Block (DCB)
- 5. (Only for using the clock delay circuits): Set the initialization bit INIT\_CLK to initiate the ΦCLK\_x delay circuits. The INIT\_CLK bit will self-clear. During this initialization step, all QCLK\_y and QREF\_r outputs are reset to the logic low state.
- 6. Enable or disable outputs as desired by accessing the output-enable registers 0x74 and 0x76.
- 7. At this point, the configuration of the registers should be completed and the SPI transfer ended. Set nCS to high level.

Registers in the address range 0x78 to 0xFF should not be used. Do not write into any registers in the 0x78 to 0xFF range.



### **Changing Frequency Dividers and Phase Delay Values**

#### Clock Frequency Divider and Delay

Following procedure has to be applied for a change of a clock divider and phase delay value  $N_{A-D_1}$  and  $\Phi_{CLKA-D_2}$ 

- 1. (Optional) set the value of the CPOL register to define the SPI read mode, so that SPI settings can be validated by subsequent SPI read accesses.
- 2. (Optional) disable the outputs whose frequency divider or delay value is changed
- 3. Configure the  $N_{A-D}$  dividers and the delay circuits  $\Phi_{CLKA-D}$  to the desired new values
- 4. Set the initialization bit INIT\_CLK. This will initiate all divider and delay circuits and synchronize them to each other. The INIT\_CLK bit will self-clear. During this initialization step, all QCLK\_y and QREF\_r outputs are reset to the logic low state
- 5. (Optional) Enable the outputs whose frequency divider was changed

### SYSREF Delay

Following procedure has to be applied for a change of any SYSREF phase delay value  $\Phi_{\mathsf{REF}}$  r.

- 1. (Optional) set the value of the CPOL register to define the SPI read mode, so that SPI settings can be validated by subsequent SPI read accesses.
- 2. Configure any delay circuits  $\Phi_{RFF}$ , to their desired new values. During configuration of  $\Phi_{RFF}$ , outputs are not stopped or interrupted.

#### **SPI Interface**

The 8V79S683 has a 3-wire serial control port capable of responding as a slave in an SPI configuration to allow read and write access to any of the internal registers for device programming or read back. The SPI interface consists of the SCLK (clock), SDAT (serial data input and output), and nCS (chip select) pins. A data transfer consists of any integer multiple of 8 bits and is always initiated by the SPI master on the bus. Internal register data is organized in SPI bytes of 8 bits each. If nCS is at logic high, the SDAT data I/O is in high-impedance state and the SPI interface of the 8V79S683 is disabled. In a write operation, data on SDAT will be clocked in on the rising edge of SCLK. In a read operation, data on SDAT will be clocked out on the falling or rising edge of SCLK depending on the CPOL setting (CPOL = 0: output data changes on the falling edge, CPOL = 1: output data changes on the rising edge).

Starting a data transfer requires nCS to set and hold at logic low level during the entire transfer. Setting nCS = 0 will enable the SPI interface with SDAT in data input mode. The master must initiate the first 8-bit transfer. The first bit presented to the slave is the direction bit R/nW (1 = Read, 0 = Write) and the following seven bits are the address bits A[0:6] pointing to an internal register in the address space 0 to 127. Data is presented with the LSB (least significant bit) first.

Read operation from an internal register: a read operation starts with an 8 bit transfer from the master to the slave: SDAT is clocked on the rising edge of SCLK. The first bit is the direction bit R/nW which must be to 1 to indicate a read transfer, followed by 7 address bits A[0:6]. After the first 8 bits are clocked into SDAT, the SDAT I/O changes to output: the register content addressed by A[0:6] is loaded into the shift register and the next 8 SCLK falling clock cycles (if CPOL = 0) will then present the loaded register data on the SDAT output and transfer these to the master. Transfers must be completed by de-asserting nCS after any multiple 8 SCLK cycles. If nCS is de-asserted at any other number of SCLKs, the SPI behavior is undefined. SPI byte (8 bit) and back-to-back read transfers of multiple registers are supported with an address auto-increment. During multiple transfers, nCS must stay at logic low level and SDAT will present multiple registers (A), (A+1), (A+2), etc. with each 8 SCLK cycles. During SPI Read operations, the user may continue to hold nCS low and provide further bytes in a single block read.

Write operation to a 8V79S683 register: During a write transfer, a SPI master transfers one or more bytes of data into the internal registers of the 8V79S683. A write transfer starts by asserting nCS to low logic level. The first bit presented by the master must set the direction bit R/nW to 0 (Write) and the 7 address bits A[0:6] must contain the 7-bit register address. Bits D0 to D7 contain 8 bit of payload data, which is written into the register addressed by A[0:6] at the end of a 8-bit write transfer. Multiple, subsequent register transfers from the master to the slave are supported by holding nCS asserted at logic low level during write transfers. The 7 bit register address will auto-increment. Transfers must be completed by de-asserting nCS after any multiple 8 SCLK cycles. If nCS is de-asserted at any other number of SCLKs, the SPI behavior is undefined.

**End of transfer:** After de-asserting nCS, the SPI bus is available to transfers to other slaves on the SPI bus. See also the READ diagram (Figure 5) and WRITE diagram (Figure 6) displaying the transfer of two bytes of data from and into registers

Registers 0x78 to 0xFF: Registers in the address range 0x78 to 0xFF should not be used. Do not write into any registers in the 0x78 to 0xFF range.

Figure 5: Logic Diagram: READ Data from 8V79S683 Registers for CPOL = 0 and CPOL = 1

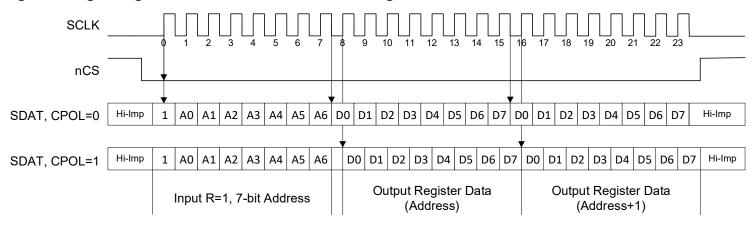
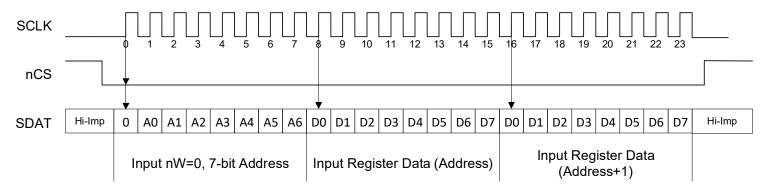


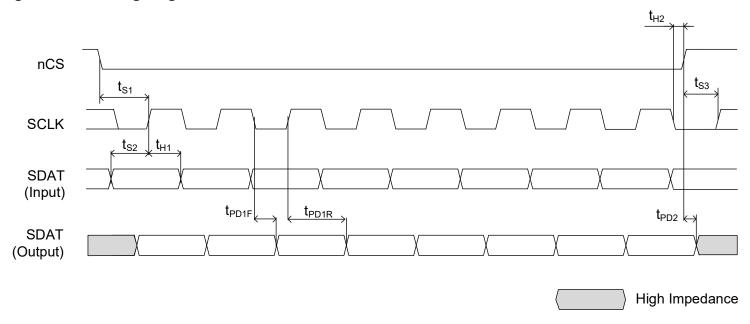
Figure 6: Logic Diagram WRITE Data into 8V79S683 Registers



**Table 13: SPI Read / Write Cycle Timing Parameters** 

| Symbol            | Parameter                                  | Test Condition | Minimum | Maximum | Unit |
|-------------------|--|----------------|---------|---------|------|
| f <sub>SCLK</sub> | SCLK frequency                             |                |         | 20      | MHz  |
| t <sub>S1</sub>   | Setup time, nCS (falling) to SCLK (rising) |                | 5       |         | ns   |
| t <sub>S2</sub>   | Setup time, SDAT (input) to SCLK (rising)  |                | 5       |         | ns   |
| t <sub>S3</sub>   | Setup time, nCS (rising) to SCLK (rising)  |                | 5       |         | ns   |
| t <sub>H1</sub>   | Hold time, SCLK (rising) to SDAT (input)   |                | 5       |         | ns   |
| t <sub>H2</sub>   | Hold time, SCLK (falling) to nCS (rising)  |                | 5       |         | ns   |
| t <sub>PD1F</sub> | Propagation delay, SCLK (falling) to SDAT  | CPOL = 0       |         | 12      | ns   |
| t <sub>PD1R</sub> | Propagation delay, SCLK (rising) to SDAT   | CPOL = 1       |         | 12      | ns   |
| t <sub>PD2</sub>  | Propagation delay, nCS to SDAT disable     |                |         | 12      | ns   |
| t <sub>R, F</sub> | Rise, Fall Time, SPI Inputs SCLK, SDAT     |                | 1       | 10      | ns   |

Figure 7: SPI Timing Diagram



## **Register Descriptions**

This section contains a list of all addressable registers and a register description, sorted by function, followed for a detailed description of each bit field for each register. Several functional blocks with multiple instances in this device have individual registers controlling their settings, but since the registers have an identical format and bit meaning, they are described only once, but with an additional table to indicate their addresses and default values. All writable register fields will come up with a default values as indicated in the Factory Defaults column unless altered by values loaded from non-volatile storage during the initialization sequence.

Fixed read-only bits will have defaults as indicated in their specific register descriptions. Read-only status bits will reflect valid status of the conditions they are designed to monitor once the internal power-up reset has been released. Unused registers and bit positions are Reserved. Reserved bit fields will be unaffected by writes and are undefined on reads.

**Table 14: Configuration Registers** 

| Register Address | Register Description                    |  |  |  |
|------------------|---|--|--|--|
| 0x00 - 0x17      | Reserved                                |  |  |  |
| 0x18 - 0x1B      | SYSREF, DCB and Phase Alignment Control |  |  |  |
| 0x1C - 0x1F      | Reserved                                |  |  |  |
| 0x20             | Channel A, Output Divider               |  |  |  |
| 0x21             | Channel A Delay ΦCLK_A                  |  |  |  |
| 0x22             | Channel A PD                            |  |  |  |
| 0x23             | Reserved                                |  |  |  |
| 0x24             | Output State QCLK_A0                    |  |  |  |
| 0x25             | Output State QCLK_A1                    |  |  |  |
| 0x26             | Output State QCLK_A2                    |  |  |  |
| 0x27             | Reserved                                |  |  |  |
| 0x28             | ΦREF_A0 Delay, MUX                      |  |  |  |



**Table 14: Configuration Registers (Continued)** 

| Register Address | Register Description      |  |  |
|------------------|---------------------------|--|--|
| 0x29             | ФREF_A1 Delay, MUX        |  |  |
| 0x2A             | ΦREF_A2 Delay, MUX        |  |  |
| 0x2B             | Reserved                  |  |  |
| 0x2C             | Output State QREF_A0      |  |  |
| 0x2D             | Output State QREF_A1      |  |  |
| 0x2E             | Output State QREF_A2      |  |  |
| 0x2F             | Reserved                  |  |  |
| 0x30             | Channel B, Output Divider |  |  |
| 0x31             | Channel B Delay ΦCLK_B    |  |  |
| 0x32             | Channel B PD              |  |  |
| 0x33             | Reserved                  |  |  |
| 0x34             | Output State QCLK_B0      |  |  |
| 0x35             | Output State QCLK_B1      |  |  |
| 0x36 - 0x37      | Reserved                  |  |  |
| 0x38             | ΦREF_B0 Delay, MUX        |  |  |
| 0x39             | ΦREF_B1 Delay, MUX        |  |  |
| 0x3A-0x3B        | Reserved                  |  |  |
| 0x3C             | Output State QREF_B0      |  |  |
| 0x3D             | Output State QREF_B1      |  |  |
| 0x3E-0x3F        | Reserved                  |  |  |
| 0x40             | Channel C, Output Divider |  |  |
| 0x41             | Channel C Delay ΦCLK_C    |  |  |
| 0x42             | Channel C PD              |  |  |
| 0x43             | Reserved                  |  |  |
| 0x44             | Output State QCLK_C0      |  |  |
| 0x45             | Output State QCLK_C1      |  |  |
| 0x46-0x47        | Reserved                  |  |  |
| 0x48             | ΦREF_C0 Delay, MUX        |  |  |
| 0x49             | ΦREF_C1 Delay, MUX        |  |  |
| 0x4A-0x4B        | Reserved                  |  |  |
| 0x4C             | Output State QREF_C0      |  |  |
| 0x4D             | Output State QREF_C1      |  |  |
| 0x4E-0x4F        | Reserved                  |  |  |
| 0x50             | Channel D, Output Divider |  |  |
|                  |                           |  |  |



**Table 14: Configuration Registers (Continued)** 

| Register Address | Register Description   |  |  |
|------------------|------------------------|--|--|
| 0x51             | Channel D Delay ΦCLK_D |  |  |
| 0x52             | Channel D PD           |  |  |
| 0x53             | Reserved               |  |  |
| 0x54             | Output State QCLK_D    |  |  |
| 0x55-0x57        | Reserved               |  |  |
| 0x58             | ΦREF_D Delay, MUX      |  |  |
| 0x59-0x5B        | Reserved               |  |  |
| 0x5C             | Output State QREF_D    |  |  |
| 0x5D-0x6B        | Reserved               |  |  |
| 0x6C-0x73        | General Control        |  |  |
| 0x74             | Output State QCLK      |  |  |
| 0x75             | Reserved               |  |  |
| 0x76             | Output State QREF      |  |  |
| 0x77             | Reserved               |  |  |
| 0x78             | Do not use             |  |  |
| 0x79             | Do not use             |  |  |
| 0x7A             | Do not use             |  |  |
| 0x7B             | Do not use             |  |  |
| 0x7C-0x7D        | Do not use             |  |  |
| 0x7E             | Do not use             |  |  |
| 0x7F             | Do not use             |  |  |
| 0x80-0xFF        | Do not use             |  |  |



## **Channel and Clock Output Registers**

The content of the channel register and clock output registers set the clock divider, output style, amplitude, power down state, enable state and the clock phase delay.

**Table 15: Channel and Clock Output Register Bit Field Locations** 

|   | Bit Field Location                                  |  |            |                                    |                                  |                            |                            |           |
|---|---|--|------------|------------------------------------|----------------------------------|----------------------------|----------------------------|-----------|
| Register Address                                | D7  | D6   | D5         | D4                                 | D3                               | D2                         | D1                         | D0        |
| 0x20<br>0x30<br>0x40<br>0x50                    | Reserved  | Reserved   | Reserved   | Reserved                           |                                  | N_E<br>N_C                 | N[3:0]<br>N[3:0]<br>N[3:0] |           |
| 0x21<br>0x31<br>0x41<br>0x51                    |   | ΦCLK_A[7:0]<br>ΦCLK_B[7:0]<br>ΦCLK_C[7:0]<br>ΦCLK_D[7:0] |            |                                    |                                  |                            |                            |           |
| 0x22<br>0x32<br>0x42<br>0x52                    | PD_ <i>A</i> PD_ <i>B</i> PD_ <i>C</i> PD_ <i>D</i> | Reserved   | Reserved   | Reserved                           | Reserved                         | Reserved                   | Reserved                   | Reserved  |
| 0x24: QCLK_A0<br>0x25: QCLK_A1<br>0x26: QCLK_A2 | PD_A0<br>PD_A1<br>PD_A2                             | Reserved   | Reserved   | STYLE_A0A1<br>Reserved<br>STYLE_A2 | Rese                             | 41[1:0]<br>erved<br>2[1:0] | Reserved                   |           |
| 0x34: QCLK_B0<br>0x35: QCLK_B1                  | PD_ <i>B0</i><br>PD_ <i>B1</i>                      | Reserved   | Reserved   | STYLE_B0B1<br>Reserved             | A_ <i>B0B1</i> [1:0]<br>Reserved |                            | Reserved                   |           |
| 0x44: QCLK_C0<br>0x45: QCLK_C1                  | PD_C0<br>PD_C1                                      | Reserved   | Reserved   | STYLE_C0<br>STYLE_C1               | A_C0[1:0]<br>A_C1[1:0]           |                            | Reserved                   |           |
| 0x54: QCLK_D                                    | PD_D  | Reserved   | Reserved   | STYLE_D                            | A_D[1:0] Res                     |                            | erved                      |           |
| 0x74  | EN_QCLK_A0  | EN_QCLK_A1   | EN_QCLK_A2 | EN_QCLK_B0                         | EN_QCLK_B1                       | EN_QCLK_C0                 | EN_QCLK_C1                 | EN_QCLK_D |



Table 16: Channel and Clock Output Register Descriptions<sup>a</sup>

| Register Description |            |                       |                                   |   |  |  |
|----------------------|------------|-----------------------|-----------------------------------|---|--|--|
| Bit Field Name       | Field Type | Default (Binary)      | Description                       |   |  |  |
|                      |            |                       | Output Frequency Divider N        |   |  |  |
|                      |            | N 4 0000 (+4)         | N_x[2:0]                          | Frequency Divider   |  |  |
|                      |            | N_A = 0000 (÷1)       | 0000                              | ÷1 (Divider bypassed and powered-down)  |  |  |
|                      |            | N <i>B</i> =          | 0001                              | ÷2  |  |  |
|                      |            | 001[NBC_DEF]          | 0010                              | ÷3  |  |  |
|                      |            | (÷4/÷3)               | 0011                              | ÷4  |  |  |
| N_x[3:0]             | R/W        | , ,                   | 0100                              | ÷6  |  |  |
|                      |            | N_C =                 | 0101                              | ÷8  |  |  |
|                      |            | 001[NBC_DEF]          | 0110                              | ÷12   |  |  |
|                      |            | ÷4/÷3                 | 0111                              | ÷16   |  |  |
|                      |            |                       | 1000                              | ÷24   |  |  |
|                      |            | $N_D = 0000 (\div 1)$ |                                   |   |  |  |
|                      |            |                       |                                   | The default value of the N_B and N_C divider is set by pin 31 (NBC_DEF). See Table 3. |  |  |
| DD.                  | D/144      | 0                     | 0 = Channel x is powered up       |   |  |  |
| PD_x                 | R/W        | Value: Power up       | 1 = Channel x is powered down     |   |  |  |
|                      |            | <u> </u>              |                                   |   |  |  |
| DD v                 | R/W        | 0                     | 0 = Output Q0                     | CLK_y is powered up   |  |  |
| PD_y                 | R/VV       | Value: Power up       | 1 = Output QCLK_y is powered down |   |  |  |
|                      |            |                       | CLK_x Phase                       | Delay   |  |  |
|                      |            | 0000 0000             | ФСLK_x[7:0]                       | Phase Delay in units of the input period: ΦCLK_x[7:0] ÷ f <sub>IN</sub> (256 steps).  |  |  |
| ФСLK_ <i>x</i> [7:0] | R/W        | 0000 0000             | 0000 0000                         | 0ps   |  |  |
| * OEK_X[1.0]         | 1,7,7      | Value: 0ns            | 0000 0001                         | 1 ÷ f <sub>IN</sub>   |  |  |
|                      |            |                       |                                   |   |  |  |
|                      |            |                       | 1111 1111                         | 255 ÷ f <sub>IN</sub>   |  |  |



Table 16: Channel and Clock Output Register Descriptions<sup>a</sup>

| Register Description   |            |                  |   |   |  |  |  |  |
|--|------------|------------------|---|---|--|--|--|--|
| Bit Field Name   | Field Type | Default (Binary) | Description   |   |  |  |  |  |
|  |            |                  | QCLK_y Output Amplitude   |   |  |  |  |  |
|  |            |                  | Setting for STYLE = 0 (LVDS)  | Setting for STYLE = 1 (LVPECL)                                  |  |  |  |  |
|  |            |                  | Termination: $100\Omega$ across   | Termination: $50\Omega$ to $V_T$                                |  |  |  |  |
|  |            | 01               | A[1:0] = 00: 350mV  | A[1:0] = 00: 350mV  |  |  |  |  |
| A_ <i>y</i> [1:0]  | R/W        | 01               | A[1:0] = 01: 750mV  | A[1:0] = 01: 750mV  |  |  |  |  |
| Α_y[1.0]   | IX/VV      | Value: 750mV     | A[1:0] = 10: Reserved   | A[1:0] = 10: 1000mV   |  |  |  |  |
|  |            | value. 700mv     | A[1:0] = 11: Reserved   | A[1:0] = 11: 1000mV   |  |  |  |  |
|  |            |                  | The following control bits combine the  | e A(mplitude) function for multiple outputs:                    |  |  |  |  |
|  |            |                  | A_A0A1 sets the output amplitude for QCLK_A0 and QCLK_A1  |   |  |  |  |  |
|  |            |                  | A_B0B1 sets the output amplitude for QCLK_B0 and QCLK_B1  |   |  |  |  |  |
|  |            |                  | QCLK_y Output Format.   |   |  |  |  |  |
| STYLE_y  |            | 0                | 0 = Output(s) is/are LVDS (requires LVDS 100Ω output termination) 1 = Output(s) is LVPECL (requires LVPECL 50Ω output termination to the specified recommended termination voltage) |   |  |  |  |  |
|  |            | Value: LVDS      | The following central hits combine the  | o STVI E function for multiple outputs:                         |  |  |  |  |
|  |            |                  | _   | e STYLE function for multiple outputs:  for OCLK A0 and OCLK A1 |  |  |  |  |
| STYLE_A0A1 sets the output format for QCLK_A0 and QCL<br>STYLE_B0B1 sets the output format for QCLK_B0 and QCL |            |                  |   |   |  |  |  |  |
|  |            | 1                | QCLK_y Output Enable:   |   |  |  |  |  |
| EN_y   |            |                  | 0 = QCLK_y Output is disabled at the  | e logic low state   |  |  |  |  |
|  |            | Value: enabled   | 1 = QCLK_y Output is enabled  |   |  |  |  |  |

a. x = A, B, C, D; y = A0, A1, A2, B0, B1, C0, C1, D.



## **QREF\_r Output State Registers**

The content of the QREF\_r output registers selects the source signal of the QREF\_r outputs, set the phase delay, the style, the amplitude, the power state, the enable state and the output bias.

Table 17: QREF\_r Output State Register Bit Field Locations<sup>a</sup>

|   | Bit Field Location             |            |                               |                                  |             |   |            |           |  |
|---|--------------------------------|------------|-------------------------------|----------------------------------|-------------|---|------------|-----------|--|
| Register Address                                | D7                             | D6         | D5                            | D4                               | D3          | D2  | D1         | D0        |  |
| 0x28: QREF_A0<br>0x29: QREF_A1<br>0x2A:QREF_A2  | Reserved                       | Reserved   | Reserved                      | MUX_A0<br>MUX_A1<br>MUX_A2       |             | ΦREF_ <i>A0</i> [2:0]<br>ΦREF_ <i>A1</i> [2:0]<br>ΦREF_ <i>A2</i> [2:0] |            | Reserved  |  |
| 0x38: QREF_B0<br>0x39: QREF_B1                  | Reserved                       | Reserved   | Reserved                      | MUX_B0<br>MUX_B1                 |             | ФREF_ <i>B0</i> [2:0]<br>ФREF_ <i>B1</i> [2:0]                          | •          | Reserved  |  |
| 0x48: QREF_C0<br>0x49: QREF_C1                  | Reserved                       | Reserved   | Reserved                      | MUX_C0<br>MUX_C1                 |             | ΦREF_C0[2:0]<br>ΦREF_C1[2:0]  | <u>.</u>   | Reserved  |  |
| 0x58: QREF_D                                    | Reserved                       | Reserved   | Reserved                      | MUX_D                            |             | ΦREF_ <i>D</i> [2:0]  |            | Reserved  |  |
| 0x2C: QREF_A0<br>0x2D: QREF_A1<br>0x2E: QREF_A2 | PD_A0<br>PD_A1<br>PD_A2        | Reserved   | BIAS_A0<br>BIAS_A1<br>BIAS_A2 | STYLE_A0<br>STYLE_A1<br>STYLE_A2 | A_ <i>A</i> | )[1:0]<br>1[1:0]<br>2[1:0]  | Reserved   | Reserved  |  |
| 0x3C: QREF_B0<br>0x3D: QREF_B1                  | PD_ <i>B0</i><br>PD_ <i>B1</i> | Reserved   | BIAS_B0<br>BIAS_B1            | STYLE_B0<br>STYLE_B1             |             | 0[1:0]<br>1[1:0]  | Reserved   | Reserved  |  |
| 0x4C: QREF_C0<br>0x4D: QREF_C1                  | PD_C0<br>PD_C1                 | Reserved   | BIAS_C0<br>BIAS_C1            | STYLE_C0<br>STYLE_C1             |             | 0[1:0]<br>1[1:0]  | Reserved   | Reserved  |  |
| 0x5C: QREF_D                                    | PD_D                           | Reserved   | BIAS_D                        | STYLE_D                          | A_ <i>D</i> | [1:0]   | Reserved   | Reserved  |  |
| 0x76  | EN_QREF_A0                     | EN_QREF_A1 | EN_QREF_A2                    | EN_QREF_B0                       | EN_QREF_B1  | EN_QREF_C0  | EN_QREF_C1 | EN_QCLK_D |  |

a. r = A0, A1, A2, B0, B1, C0, C1, D.



Table 18: QREF\_r Output State Register Descriptions<sup>a</sup>

| Register Description |            |                          |  |  |                |  |  |  |
|----------------------|------------|--------------------------|--|--|----------------|--|--|--|
| Bit Field Name       | Field Type | Default<br>(Binary)      | Description  |  |                |  |  |  |
| MUX_r                | R/W        | 1 Value: QREF_r = SYSREF | 0 = QREF_r output signal source is the channel's clock signal 1 = QREF_r output signal source is the centrally generated SYSREF signal |  |                |  |  |  |
| ΦREF_r[2:0]          | R/W        | 000<br>Value: 0ps        | 001     131     262     393     524       010     262     524     786     1048   |  |                |  |  |  |
| BIAS_r               | R/W        | 0                        | set to LVPECI<br>0 = Normal op<br>1 = Output is I<br>is set to 1. Bit  | EF_ <i>r</i> output L'<br>L mode.<br>peration<br>biased to the l | 1834 2751 3668 |  |  |  |



Table 18: QREF\_r Output State Register Descriptions<sup>a</sup>

| Register Description |            |                      |   |                                  |  |  |  |  |
|----------------------|------------|----------------------|---|----------------------------------|--|--|--|--|
| Bit Field Name       | Field Type | Default<br>(Binary)  | Description   |                                  |  |  |  |  |
|                      |            |                      | QREF_r Output Amplitude   |                                  |  |  |  |  |
|                      |            | 0.4                  | Setting for STYLE = 0 (LVDS)  | Setting for STYLE = 1 (LVPECL)   |  |  |  |  |
|                      |            | 01                   | Termination: 100Ω across  | Termination: $50\Omega$ to $V_T$ |  |  |  |  |
| A_r[1:0]             | R/W        | Value:               | A[1:0] = 00: 350mV  | A[1:0] = 00: 350mV               |  |  |  |  |
|                      |            | 750mV                | A[1:0] = 01: 750mV  | A[1:0] = 01: 750mV               |  |  |  |  |
|                      |            |                      | A[1:0] = 10: Reserved   | A[1:0] = 10: 1000mV              |  |  |  |  |
|                      |            |                      | A[1:0] = 11: Reserved   | A[1:0] = 11: 1000mV              |  |  |  |  |
|                      | R/W        | 0                    | QREF_r Output Power Down:  0 = Output is powered up  1 = Output is powered down. STYLE, EN and A[1:0] settings have no effect |                                  |  |  |  |  |
| PD_r                 |            | Value:<br>Powered up |   |                                  |  |  |  |  |
|                      |            | 0                    | QREF_x Output Format.   |                                  |  |  |  |  |
| STYLE_r              | R/W        |                      | $0 = \text{Output} \text{ is LVDS (requires LVDS } 100\Omega$   | . ,                              |  |  |  |  |
|                      |            | Value: LVDS          | 1 = Output is LVPECL (requires LVPECL $50\Omega$ output termination of to the specified recommended termination voltage)      |                                  |  |  |  |  |
|                      |            | 0                    | QREF_r Output Enable:   |                                  |  |  |  |  |
| EN_r                 | R/W        |                      | 0 = Output is disabled at the logic low state   |                                  |  |  |  |  |
|                      |            | Value:<br>Disabled   | 1 = Output is enabled   |                                  |  |  |  |  |

a. r = A0, A1, A2, B0, B1, C0, C1, D. x = A, B, C, D



## SYSREF, DCB, and Phase Alignment Control Registers

## Table 19: SYSREF, DCB and Phase Alignment Control Register Bit Field Locations

|                  | Bit Field Location |          |                   |          |            |          |          |          |  |  |
|------------------|--------------------|----------|-------------------|----------|------------|----------|----------|----------|--|--|
| Register Address | D7                 | D6       | D6 D5 D4 D3 D2 D1 |          |            |          |          |          |  |  |
| 0x18             | PD_S               | Reserved | Reserved          | Reserved | Reserved   | Reserved | Reserved | Reserved |  |  |
| 0x19             | BIAS_TYPE          | DLC      | [1:0]             | Reserved | Reserved   | Reserved | Reserved | M_DCB[8] |  |  |
| 0x1A             |                    |          |                   | M_D(     | CB[7:0]    |          |          |          |  |  |
| 0x1B             | N_ALIGN            |          |                   |          | P_DCB[6:0] |          |          |          |  |  |

### Table 20: SYSREF, DCB and Phase Alignment Control Register Descriptions

|                |            |                           | Regis           | ter Description  | n   |  |  |  |
|----------------|------------|---------------------------|-----------------|--|---|--|--|--|
| Bit Field Name | Field Type | Default<br>(Binary)       | Description     |  |   |  |  |  |
| PD_S           | R/W        | 0<br>Value:<br>Powered up | 0 = SYSREF f    | YSREF Global Power-down:  = SYSREF functional blocks are powered-up = SYSREF functional blocks are powered-down  |   |  |  |  |
|                |            |                           | Global to all C | SYSREF Output Voltage Bias:  Global to all QREF_r outputs bit to control the LVDS output operation. Not applicable to QREF_r outputs set to LVPECL mode. |   |  |  |  |
|                |            | V 0                       | BIAS_TYPE 0     | BIAS_r   | QREF_r output operation if set to LVDS.  QREF_r outputs are initially logic low (QREF_r = L, nQREF_r = H) and will start switching on the first rising edge of the REF input. Use in DC-coupled applications. |  |  |  |
| BIAS_TYPE      | R/W        |                           | 0               | 1  | Disabled with static low/high levels. During a SYSREF event, the output remains at static low levels (QREF_r = L, nQREF_r = H).   |  |  |  |
|                |            |                           | 1               | 0  | Both QREF_r and nQREF_r outputs are initially set to the LVDS crosspoint level (VOS) and will start switching on the first rising edge of the REF input. Use in AC-coupled applications.                      |  |  |  |
|                |            |                           | 1               | 1  | Output is statically set to the LVDS crosspoint voltage. During a SYSREF event, the output remains at the LVDS crosspoint level (VOS).  |  |  |  |



### Table 20: SYSREF, DCB and Phase Alignment Control Register Descriptions

|                |            |                          | Regis                           | ster Description  |  |  |  |
|----------------|------------|--------------------------|---------------------------------|---|--|--|--|
| Bit Field Name | Field Type | Default<br>(Binary)      |                                 | Description   |  |  |  |
| DLC[1:0]       | R/W        | 00<br>Value: 131ps       | DLC[1:0]<br>00<br>01<br>10      | ey unit for the SYSREF outputs is (1 + DLC[1:0]) ÷ (8 · f <sub>DCO</sub> ).  Effective SYSREF Delay Unit for f <sub>DCO</sub> = 983.04MHz  131ps  262ps  393ps  |  |  |  |
| M_DCB[8:0]     | R/W        | 0 0001 0000<br>Value: 16 | Delay Calibra                   | Delay Calibration Block (DCB) DCO feedback divider. Set in conjunction with f <sub>IN</sub> and P_DCB to achieve a DCO frequency of 983.04±20MHz: f <sub>DCO</sub> = f <sub>IN</sub> ÷ P <sub>DCB</sub> · M <sub>DCB</sub> .  |  |  |  |
| N_ALIGN        | R/W        | 0<br>Value: ÷24          | multi-device p<br>÷16. The divi | vider dividing the input clock signal $(f_{IN})$ to an internal reference for the phase alignment engine. Use $\div 48$ if any of the output clock divider is $N_x = 4$ der setting has an impact on the max. frequency $f_{REF}$ during multi-device lent (see $f_{REF}$ in AC characteristics table). |  |  |  |
| P_DCB[6:0]     | R/W        | 000 1000<br>Value: 8     | to achieve DO                   | ation Block (DCB) DCO input divider. Set in conjunction with $f_{IN}$ and M_DCB CO frequency of 983.04±20MHz: $f_{DCO} = f_{IN} \div P_{DCB} \cdot M_{DCB}$ . DCO phase uency should not exceed 200MHz.   |  |  |  |



## **General Control Registers**

## **Table 21: General Control Register Bit Field Locations**

|                  |                |          | Bit F          | ield Location |          |          |          |          |  |  |  |
|------------------|----------------|----------|----------------|---------------|----------|----------|----------|----------|--|--|--|
| Register Address | D7             | D6       | D5             | D4            | D3       | D2       | D1 D0    |          |  |  |  |
| 0x6C             | Reserved       |          | DAC_CODE[14:8] |               |          |          |          |          |  |  |  |
| 0x6D             |                |          |                | DAC_C         | ODE[7:0] |          |          |          |  |  |  |
| 0x6E             | Reserved       | Reserved | Reserved       | Reserved      | Reserved | Reserved | ST_READY | Reserved |  |  |  |
| 0x6F             | Reserved       | Reserved |                |               | PBIA     | .S[5:0]  |          |          |  |  |  |
| 0x70             | INIT_CLK       | Reserved | Reserved       | Reserved      | Reserved | Reserved | Reserved | Reserved |  |  |  |
| 0x71             | DCB_CAL        | Reserved | Reserved       | Reserved      | Reserved | Reserved | Reserved | Reserved |  |  |  |
| 0x72             | PB_CAL         | Reserved | Reserved       | Reserved      | Reserved | Reserved | Reserved | Reserved |  |  |  |
| 0x73             | MD_ALIGN_<br>Φ | Reserved | Reserved       | Reserved      | Reserved | Reserved | Reserved | CPOL     |  |  |  |



**Table 22: General Control Register Descriptions** 

|                |                      |                     | Register Description   |
|----------------|----------------------|---------------------|--|
| Bit Field Name | Field Type           | Default<br>(Binary) | Description  |
| DAC_CODE[14:0] | R only               | Х                   | DAC_CODE is the result of the internal DCB calibration routine. Trigger calibration by setting the DCB_CAL bit.  |
| ST_READY       | R only               | Х                   | Internal startup routine completion status. The device is ready for operation when this bit is set to 1.  0 = Incomplete 1 = Completed and device is ready for operation.  |
| PBIAS[5:0]     | R only               | Х                   | BIAS level.  |
| INIT_CLK       | W only<br>Auto-Clear | Х                   | Clock divider and phase clock phase delay initialization.  Set INIT_CLK = 1 to initialize N_x divider and ΦCLK_x clock phase delay functions.  Required as part of the startup procedure and after each change of a clock divider or clock phase delay value.  |
| PB_CAL         | W only<br>Auto-Clear | Х                   | Precision Bias Calibration:  Set PB_CAL to 1 starts the auto-calibration of an internal precision bias current source.  The bias current is used as reference for outputs configured as LVDS. This bit will auto-clear after the calibration completed. Required to set as part of the startup procedure.    |
| DCB_CAL        | W only<br>Auto-Clear | Х                   | DCB Calibration:  Setting this bit to 1 will begin the auto-calibration of the DCB. The DCB provides a reference for the SYSREF delay circuits. This bit will auto-clear. This bit should be set as part of the startup procedure. The result of the calibration routine is stored in the DAC_CODE register. |
| CPOL           | R/W                  | 0                   | SPI Read Operation SCLK Polarity:  0 = Data bits on MISO are output at the falling edge of SCLK edge.  1 = Data bits on MISO are output at the rising edge of SCLK edge.   |
| MD_ALIGN_Φ     | R/W<br>Auto-clear    | 0                   | Multi-Buffer Phase Alignment Enable  0 = Multi-buffer phase alignment is disabled  1 = Multi-buffer phase alignment is enabled. The next rising edge at the REF input will start the phase alignment.  |



### **Electrical Characteristics**

## **Absolute Maximum Ratings**

The absolute maximum ratings are stress ratings only. Stresses greater than those listed below can cause permanent damage to the device. Functional operation of the 8V79S683 at absolute maximum ratings is not implied. Exposure to absolute maximum rating conditions may affect device reliability.

**Table 23: Absolute Maximum Ratings** 

| Item  | Rating                            |
|---|-----------------------------------|
| Supply Voltage, V <sub>DD_V</sub>                                 | 3.6V                              |
| Inputs  | -0.5V to V <sub>DD_V</sub> + 0.5V |
| Outputs, V <sub>O</sub> (LVCMOS)                                  | -0.5V to V <sub>DD_V</sub> + 0.5V |
| Outputs, I <sub>O</sub> (LVPECL) Continuous Current Surge Current | 50mA<br>100mA                     |
| Outputs, I <sub>O</sub> (LVDS) Continuous Current Surge Current   | 50mA<br>100mA                     |
| Input termination current, I <sub>VT</sub>                        | ±35mA                             |
| Junction Temperature, T <sub>J</sub>                              | 150°C                             |
| Storage Temperature, T <sub>STG</sub>                             | -65°C to 150°C                    |
| ESD - Human Body Model <sup>a</sup>                               | 2000V                             |
| ESD - Charged Device Model <sup>a</sup>                           | 500V                              |

a. According to JEDEC JS-001-2012/JESD22-C101.

#### **Table 24: Recommended Operating Conditions**

| Item  | Rating |
|---|--------|
| Supply Voltage, V <sub>DD_V</sub>                           | 3.3V   |
| Operating Junction Temperature, T <sub>J</sub> <sup>a</sup> | ≤125°C |
| Board Temperature, T <sub>B</sub>                           | ≤105°C |

a. 125°C/10year lifetime is based on the evaluation of intrinsic wafer process technology reliability metrics. The limiting wafer level reliability factor for this technology with respect to high temperature operation is electro-migration. The device is verified to the maximum operating junction temperature through simulation.



#### **Pin Characteristics**

Table 25: Pin Characteristics,  $V_{DD\_V}$  = 3.3V ± 5%,  $T_A$  = -40°C to +105°C

| Symbol           | Parameter                | Test Conditions    | Minimum | Typical | Maximum | Units |
|------------------|--------------------------|--------------------|---------|---------|---------|-------|
| C <sub>IN</sub>  | Input Capacitance        |                    |         | 2       | 4       | pF    |
| R <sub>PD</sub>  | Input Pull-Down Resistor | SCLK               |         | 51      |         | kΩ    |
| R <sub>PU</sub>  | Input Pull-Up Resistor   | nCS                |         | 51      |         | kΩ    |
| R <sub>OUT</sub> | LVCMOS Output Impedance  | SDAT (when output) |         | 25      |         | Ω     |

### **DC Characteristics**

Table 26: Power Supply DC Characteristics,  $V_{DD\ V}$  = 3.3V ± 5%,  $T_A$  = -40°C to +105°C<sup>a</sup>

| Symbol                  | Parameter            | Test Conditions  | Minimum | Typical | Maximum | Units |
|-------------------------|----------------------|--|---------|---------|---------|-------|
| $V_{DD_{-}V}$           | Core Supply Voltage  |  | 3.135   | 3.3     | 3.465   | V     |
| I <sub>DD</sub> (Total) | Power Supply Current | QCLK_y and QREF_r set to LVDS, 750mV amplitude, terminated $100\Omega$ , Nx dividers set to $\div 1$ |         | 820     | 960     | mA    |

a. Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

Table 27: Typical Power Supply Current Characteristics,  $V_{DD\_V}$  = 3.3V,  $T_A$  = 25°C<sup>a</sup>

| Symbol                | Supply Pin Current   |  | Test Case |        |      |      |      |      | Unit  |
|-----------------------|--|--|-----------|--------|------|------|------|------|-------|
| Symbol                |  |  | 1         | 2      | 3    | 4    | 5    | 6    | Offic |
|                       |  | Style  | LVPECL    | LVPECL | LVDS | LVDS | LVDS | LVDS |       |
|                       | QCLK_y   | State  | On        | On     | On   | On   | On   | On   |       |
|                       |  | Amplitude  | 350       | 750    | 350  | 350  | 750  | 750  | mV    |
|                       |  | Style  |           | LVDS   | LVDS | LVDS | LVDS | LVDS |       |
|                       | QREF_r   | State  | Off       | Off    | Off  | On   | On   | On   |       |
|                       |  | Amplitude  | -         | _      | -    | 350  | 350  | 750  | mV    |
| I <sub>DD_SC</sub>    | Current through the pins   | Current through the V <sub>DD_SPI</sub> ,V <sub>DD_CLK</sub> |           | 124    | 125  | 125  | 125  | 125  | mA    |
| I <sub>DD_CLKAB</sub> | Current through the $V_{ m DD\_QCLKA}$ , $V_{ m DD\_QCLKB}$ pins |  | 73        | 84     | 134  | 134  | 187  | 186  | mA    |
| I <sub>DD_CLKCD</sub> | Current through the V <sub>DD_QCLKD</sub> pins                   | Current through the V <sub>DD QCLKC</sub> ,                  |           | 65     | 94   | 94   | 126  | 126  | mA    |



Table 27: Typical Power Supply Current Characteristics,  $V_{DD\ V}$  = 3.3V,  $T_A$  = 25°C $^a$ 

| Symbol                | Supply Pin Current   | Test Case |      |      |      |      |      | Unit  |
|-----------------------|--|-----------|------|------|------|------|------|-------|
| ,                     | Supply Fill Current  | 1         | 2    | 3    | 4    | 5    | 6    | Oilit |
| I <sub>DD_REFAB</sub> | Current through the V <sub>DD_REF</sub> , V <sub>DD_QREFA01</sub> , V <sub>DD_QREFA2</sub> , V <sub>DD_QREFB</sub> | 37        | 38   | 107  | 230  | 230  | 283  | mA    |
| I <sub>DD_REFCD</sub> | Current through the V <sub>DD_QREFC</sub> , V <sub>DD_QREFD</sub> pins   | 4         | 5    | 9    | 83   | 83   | 115  | mA    |
| P <sub>TOT</sub>      | Total Device Power Consumption   | 1.15      | 1.28 | 1.55 | 2.20 | 2.48 | 2.76 | W     |
| P <sub>TOT, SYS</sub> | Total System Power Consumption <sup>b</sup>  | 1.54      | 1.75 | 1.55 | 2.20 | 2.48 | 2.76 | W     |

a. f<sub>IN</sub> (input) = 491.52MHz, f<sub>SYSREF</sub> = 7.68MHz. Supply current is independent on the output frequency. QCLK\_y outputs terminated according to amplitude settings. QREF\_r outputs unterminated when SYSREF is turned off.

Table 28: LVCMOS DC Characteristics,  $V_{DD\ V}$  = 3.3V ± 5%,  $T_A$  = -40°C to +105°C<sup>a</sup>

| Symbol          | Parameter             |         | Test Conditions                                  | Minimum | Typical | Maximum           | Units |
|-----------------|-----------------------|---------|--|---------|---------|-------------------|-------|
| V <sub>IH</sub> | Input High<br>Voltage | NBC_DEF |  | 2.0     |         | V <sub>DD_V</sub> | V     |
| V <sub>IL</sub> | Input Low<br>Voltage  | NBC_DEF |  | -0.3    |         | 0.8               | V     |
| I <sub>IH</sub> | Input<br>High Current | NBC_DEF | V <sub>DD_V</sub> = 3.3V, V <sub>IN</sub> = 3.3V |         |         | 5                 | μΑ    |
| I <sub>IL</sub> | Input<br>Low Current  | NBC_DEF | V <sub>DD_V</sub> = 3.3V, V <sub>IN</sub> = 0V   | -150    |         |                   | μΑ    |

a. Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

b. Includes total device power consumption and the power dissipated in external output termination components.



Table 29: LVCMOS (JESD8-7A, 1.8V) DC Characteristics,  $V_{DD\_V}$  = 3.3V ± 5%,  $T_A$  = -40°C to +105°C<sup>a b</sup>

| Symbol          |  | Parameter          | Test Conditions                                  | Minimum | Typical | Maximum | Units |
|-----------------|--|--------------------|--|---------|---------|---------|-------|
| V <sub>T+</sub> | Positive-going input threshold voltage | SCLK, nCS, SDAT    |  | 0.660   |         | 1.365   | V     |
| V <sub>T-</sub> | Negative-going input threshold voltage |                    |  | 0.495   |         | 1.170   | V     |
| V <sub>H</sub>  | Hysteresis<br>Voltage                  |                    | V <sub>T+</sub> – V <sub>T-</sub>                | 0.165   |         | 0.780   | V     |
| I <sub>IH</sub> | Input<br>High Current                  |                    | V <sub>DD_V</sub> = 3.3V, V <sub>IN</sub> = 1.8V |         |         | 150     | μΑ    |
| I <sub>IL</sub> | Input<br>Low Current                   |                    | V <sub>DD_V</sub> = 3.465V, V <sub>IN</sub> = 0V | -150    |         |         | μΑ    |
| V <sub>OH</sub> | Output<br>High Voltage                 | CDAT (when autout) | I <sub>OH</sub> = -4mA                           | 1.4     |         |         | V     |
| V <sub>OL</sub> | Output<br>Low Voltage                  | SDAT (when output) | I <sub>OL</sub> = 4mA                            |         |         | 0.45    | V     |

a. Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

Table 30: Differential Input DC Characteristics,  $V_{DD\_V}$  = 3.3V ± 5%,  $T_A$  = -40°C to +105°C<sup>a</sup>

| Symbol          | Parameter                        |                        | Test Conditions | Minimum | Typical | Maximum | Units |
|-----------------|----------------------------------|------------------------|-----------------|---------|---------|---------|-------|
| R <sub>IN</sub> | Input Resistance                 | CLK, nCLK<br>REF, nREF |                 | 43.5    | 50      | 56.5    | Ω     |
| I R             | Differential Input<br>Resistance | CLK, nCLK<br>REF, nREF |                 | 87      | 100     | 113     | Ω     |

a. Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

b. Table is valid for the SPI interface pins nCS, SCLK and SDAT. SPI inputs have hysteresis.



Table 31: LVPECL DC Characteristics (QCLK\_y, QREF\_r, STYLE = 1),  $V_{DD\_V}$  = 3.3V ± 5%,  $T_A$  = -40°C to +105°C<sup>a</sup>

| Symbol          | Parameter                        | Test Conditions          | Minimum                  | Typical                  | Maximum                  | Units |
|-----------------|----------------------------------|--------------------------|--------------------------|--------------------------|--------------------------|-------|
| V <sub>OH</sub> | Output High Voltage <sup>b</sup> | Any Amplitude Setting    | V <sub>DD_V</sub> - 1.20 | V <sub>DD_V</sub> - 0.90 | V <sub>DD_V</sub> - 0.60 | V     |
| V <sub>OL</sub> | h h                              | 350mV Amplitude Setting  | V <sub>DD_V</sub> - 1.40 | V <sub>DD_V</sub> - 1.24 | V <sub>DD_V</sub> - 1.05 | V     |
|                 | Output Low Voltage <sup>b</sup>  | 750mV Amplitude Setting  | V <sub>DD_V</sub> - 1.90 | V <sub>DD_V</sub> - 1.71 | V <sub>DD_V</sub> - 1.60 | V     |
|                 |                                  | 1000mV Amplitude Setting | V <sub>DD_V</sub> - 2.20 | V <sub>DD_V</sub> - 1.98 | V <sub>DD_V</sub> - 1.80 | V     |

- a. Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.
- b. Outputs terminated with  $50\Omega$  to  $V_T = V_{DD\_V} 1.6V$  (350mV amplitude setting),  $V_{DD\_V} 2.0V$  (750mV amplitude setting),  $V_{DD\_V} 2.25V$  (1000mV amplitude setting)

Table 32: LVDS DC Characteristics (QCLK\_y, QREF\_r, STYLE = 0),  $V_{DD_V}$  = 3.3V ± 5%,  $T_A$  = -40°C to +105°C<sup>a b</sup>

| Symbol          | Parameter                        | Test Conditions         | Minimum | Typical | Maximum | Units |
|-----------------|----------------------------------|-------------------------|---------|---------|---------|-------|
| V <sub>OS</sub> | Offset Voltage <sup>c</sup>      | 350mV Amplitude Setting | 1.20    | 1.25    | 1.30    | V     |
|                 | Onset voitage                    | 750mV Amplitude Setting | 1.25    | 1.30    | 1.35    | V     |
| $\Delta V_{OS}$ | V <sub>OS</sub> Magnitude Change |                         |         |         | 50      | mV    |

a. Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

- b. Outputs are terminated  $100\Omega$ .
- c. V<sub>OS</sub> changes with V<sub>DD V</sub>.



### **AC Characteristics**

# Table 33: AC Characteristics, $V_{DD\_V}$ = 3.3V ± 5%, $T_A$ = -40°C to +105°C<sup>a</sup>

| Symbol                          | Parame  | eter                   | Test Conditions  | Minimum  | Typical | Maximum                                      | Units      |
|---------------------------------|---|------------------------|--|----------|---------|--|------------|
|                                 |   |                        | Single device  | 0        | 983.04  | 3000   | MHz        |
| f <sub>IN</sub>                 | Input Frequency <sup>b</sup>  | CLK, nCLK              | Phase alignment between multiple devices                                     | >0       |         | 1000   | MHz        |
|                                 |   |                        | SYSREF operation   | 0        |         | 100  | MHz        |
| f <sub>REF</sub>                | Input Frequency   | REF, nREF              | During multi-device phase alignment <sup>c</sup> N_ALIGN = ÷24 N_ALIGN = ÷48 | >0<br>>0 |         | f <sub>IN</sub> ÷ 48<br>f <sub>IN</sub> ÷ 96 | MHz<br>MHz |
| V <sub>IN</sub>                 | Input Voltage<br>Amplitude <sup>d</sup>                                 | CLK, nCLK<br>REF, nREF |  | 0.15     |         | 1.2  | V          |
| V <sub>DIFF_IN</sub>            | Differential Input<br>Voltage<br>Amplitude <sup>d e</sup>               | CLK, nCLK<br>REF, nREF |  | 0.3      |         | 2.4  | V          |
| V <sub>CMR</sub>                | Common Mode In  | put Voltage            |  | 1        |         | V <sub>DD_V</sub> - (V <sub>IN</sub> / 2)    | V          |
| f                               | Output Frequency  |                        | QCLK_y, QREF_r (Clock), N = ÷1 to ÷24  | 0        | 983.04  | 3000÷N                                       | MHz        |
| f <sub>OUT</sub>                |   |                        | QREF_r (SYSREF)  | 0        |         | 100  | MHz        |
|                                 | Output Duty Cycle <sup>f</sup>  |                        | QCLK_y, QREF_r (Clock), $f_{IN} \le 2500MHz$                                 | 45       | 50      | 55   | %          |
| odc                             |   |                        | QCLK_y, QREF_r (Clock),<br>2500MHz < f <sub>IN</sub> ≤ 3000MHz               | 42       | 50      | 58   | %          |
|                                 |   |                        | QREF_r (SYSREF at 7.68MHz)   | 45       | 50      | 55   | %          |
|                                 | Output Rise/Fall Time   |                        | QCLK_y, QREF_r (LVPECL), 20% to 80%  |          |         | 250  | ps         |
| t <sub>R</sub> / t <sub>F</sub> |   |                        | QCLK_y, QREF_r (LVDS), 20% to 80%  |          |         | 250  | ps         |
|                                 |   |                        | QREF_r (SYSREF, LVDS), 20% to 80%  |          |         | 250  | ps         |
|                                 | LVPECL Output Voltage Swing,<br>Peak-to-peak, 491.52MHz                 |                        | 350mV Amplitude Setting  | 250      | 350     | 450  | mV         |
|                                 |   |                        | 750mV Amplitude Setting  | 650      | 750     | 850  | mV         |
| V 9                             |   |                        | 1000mV Amplitude Setting   | 900      | 1000    | 1100   | mV         |
| V <sub>O(PP)</sub> <sup>g</sup> | LVPECL Differential Output<br>Voltage Swing, Peak-to-peak,<br>491.52MHz |                        | 350mV Amplitude Setting  | 500      | 700     | 900  | mV         |
|                                 |   |                        | 750mV Amplitude Setting  | 1300     | 1500    | 1700   | mV         |
|                                 |   |                        | 1000mV Amplitude Setting   | 1800     | 2000    | 2200   | mV         |
|                                 | LVDS Output Voltage Swing,<br>Peak-to-peak, 491.52MHz                   |                        | 350mV Amplitude Setting  | 250      | 350     | 450  | mV         |
| , , h                           |   |                        | 750mV Amplitude Setting  | 600      | 750     | 900  | mV         |
| V <sub>O(PP)</sub> <sup>h</sup> | LVDS Differential Output<br>Voltage Swing, Peak-to-peak,<br>491.52MHz   |                        | 350mV Amplitude Setting  | 500      | 700     | 900  | mV         |
|                                 |   |                        | 750mV Amplitude Setting  | 1200     | 1500    | 1800   | mV         |



Table 33: AC Characteristics,  $V_{DD\ V}$  = 3.3V ± 5%,  $T_A$  = -40°C to +105°C<sup>a</sup>

| Symbol          | Parameter   | Test Conditions   | Minimum | Typical | Maximum | Units |
|-----------------|---|---|---------|---------|---------|-------|
|                 |   | QCLK_y (same N divider)k  |         |         | 100     | ps    |
|                 | O L LOL NOTELL  | QCLK_y (any N divider, incident rising edge)  |         |         | 100     | ps    |
| tsk(o)          | Output Skew; NOTE <sup>i j</sup><br>All delays set to 0                   | QREF_r (Clock)  |         |         | 100     | ps    |
|                 | All delays set to 0   | QREF_r (SYSREF)   |         |         | 100     | ps    |
|                 |   | QCLK_y to QREF_r (QREF_r as clock output) <sup>k</sup>                                  |         |         | 200     | ps    |
| tok(nn)         | Part-to-part skew   | CLK to any QCLK_y <sup>k</sup>  |         |         | 375     | ps    |
| tsk(pp)         | All delays set to 0   | REF to any QREF_r   |         |         | 375     | ps    |
|                 | Propagation Delay <sup>k</sup>  | CLK to QCLK_y <sup>k</sup>  | 250     |         | 750     | ps    |
| t <sub>PD</sub> | All delay circuits set to 0   | REF to QREF_ $r$ ( $\Phi$ REF_ $y$ = 0)   | 600     | 800     | 1000    | ps    |
| $\Delta t_{PD}$ | Propagation delay variation between the clock input and any QCLK_y output | CLK to QCLK_y <sup>k</sup>  | -100    |         | +100    | ps    |
| t <sub>S</sub>  | Setup time <sup>l</sup>   | REF to CLK (rising)   |         |         | 250     | ps    |
| t <sub>H</sub>  | Hold time   | CLK (rising) to REF   |         |         | 250     | ps    |
|                 | Output isolation between any  | $f_{QCLK\_y} = 983.04MHz^m$   | 60      |         |         | dB    |
|                 | QCLK_y-QCLK_y and   | $f_{QCLK\_y} = 491.52MHz^m$   | 65      |         |         | dB    |
|                 | QREF_r-QREF_r outputs   | $f_{QCLK\_y} = 245.76MHz^m$   | 70      |         |         | dB    |
|                 | Output isolation between any QREF_r/QCLK_y outputs                        | f <sub>QCLK_y</sub> = 983.04MHz, 491.52MHz,<br>245.76MHz; f <sub>QREF_r</sub> = 7.68MHz | 50      |         |         | dB    |

- a. Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.
- b. The CLK, nCLK input supports 0Hz if the applied static signal has a minimum amplitude as specified by  $V_{IN}$ ,  $V_{DIFF\_IN}$ .
- c. Only applicable to a multi-device phase alignment procedure as a max frequency for applying multiple edges to the REF input. This specification is not applicable if a single REF edge is used for multi-device phase alignment.
- d.  $V_{IL}$  should not be less than -0.3V and  $V_{IH}$  should not be greater than  $V_{DD}$   $V_{L}$
- e. Common Mode Input Voltage is defined as the cross-point voltage.
- f. Input = 50% duty cycle.
- g. LVPECL outputs terminated with  $50\Omega$  to  $V_T = V_{DD\_V} 1.6V$  (350mV amplitude setting),  $V_{DD\_V} 2.0V$  (750mV amplitude setting),  $V_{DD\_V} 2.25V$  (1000mV amplitude setting).
- h. LVDS outputs terminated  $100\Omega$  across Q, nQ.
- i. This parameter is defined in accordance with JEDEC standard 65.
- j. Defined as skew between outputs at the same supply voltage and with equal load conditions. Measured at the differential cross points
- k. All frequency dividers N are in ÷1, ÷2, ÷4 or ÷8; output amplitude setting 750mV.
- I. Failure to meet CLK/REF setup and hold time can result in a failure to align output phases across multiple devices
- m. Output amplitudes set to 350mV or 750mV.



Table 34: DCB and Phase Delay Characteristics,  $V_{DD\_V}$  = 3.3V ± 5%,  $T_A$  = -40°C to +105°C<sup>a</sup>

| Symbol                         | Parameter                    | Test C  | onditions               | Minimum                 | Typical | Maximum | Units |    |
|--------------------------------|------------------------------|---|-------------------------|-------------------------|---------|---------|-------|----|
| $f_{DCO}$                      | DCO Lock Range               |   |                         | 963.04                  | 983.04  | 1003.04 | MHz   |    |
|                                |                              |   | DLC = 1 (DLC[1:0] = 00) | 115                     | 131     | 150     | ps    |    |
|                                |                              | f - 002 04MH-   | DLC = 2 (DLC[1:0] = 01) | 230                     | 262     | 300     | ps    |    |
|                                |                              | f <sub>DCO</sub> = 983.04MHz  | DLC = 3 (DLC[1:0] = 10) | 345                     | 393     | 450     | ps    |    |
|                                |                              |   | DLC = 4 (DLC[1:0] = 11) | 460                     | 524     | 600     | ps    |    |
|                                |                              |   | DLC = 1 (DLC[1:0] = 00) | 113                     | 134     | 152     | ps    |    |
| Т                              | ΦREF_r Delay Unit Range      | f <sub>DCO</sub> = 963.04MHz  | DLC = 2 (DLC[1:0] = 01) | 226                     | 268     | 304     | ps    |    |
| T <sub>DCB</sub>               | CB WREF_/ Delay Utilit Kange | ΨΚΕΓ_/ Delay Offic Kange  | (min DCO frequency)     | DLC = 3 (DLC[1:0] = 10) | 339     | 402     | 456   | ps |
|                                |                              |   | DLC = 4 (DLC[1:0] = 11) | 452                     | 536     | 608     | ps    |    |
|                                |                              |   | DLC = 1 (DLC[1:0] = 00) | 112                     | 128     | 142     | ps    |    |
|                                |                              | f <sub>DCO</sub> = 1003.04MHz   | DLC = 2 (DLC[1:0] = 01) | 224                     | 256     | 284     | ps    |    |
|                                |                              |   | (max DCO frequency)     | DLC = 3 (DLC[1:0] = 10) | 336     | 384     | 426   | ps |
|                                |                              |   | DLC = 4 (DLC[1:0] = 11) | 448                     | 512     | 568     | ps    |    |
| T <sub>IN</sub> b              | ΦCLK_x Delay Unit            | f <sub>IN</sub> = 983.04MHz   |                         |                         | 1017    |         | ps    |    |
| f <sub>1,</sub> f <sub>2</sub> | DCO Phase Detector Frequency |   |                         |                         |         | 200     | MHz   |    |
| $\Delta t_{D}$                 | Delay unit variation         | $\Phi$ REF_r delay unit variation (deviation from nominal, DLC[1:0] = 00) |                         | -30                     | 0       | +30     | ps    |    |
|                                |                              | ΦCLK_y delay unit variation (deviation from nominal)                      |                         | -20                     | 0       | +20     | ps    |    |

a. Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

b.  $\Phi$ CLK\_x clock channel delay unit is equal to 1 ÷  $f_{IN}$ .



#### **Additive Clock Phase Noise Characteristics**

The 8V79S683 is a buffer device, it does not filter the phase noise on the input clock source. Phase noise caused by noise sources within the device can add to the input signal noise, resulting in an increased noise on the outputs (additive phase noise). Phase noise from within the part is not correlated with the noise on the input, therefore the root-sum-square method must be used to calculate the output phase noise:  $\Phi_{\text{OUT}}^2 = \Phi_{\text{IN}}^2 + \Phi_{\text{DEVICE}}^2.$  As a consequence, at frequency offsets where the input phase noise  $\Phi_{\text{IN}}$  is higher than internal noise sources, the effect of additive phase noise is not measurable.

Simulations of the device phase noise performance are done with an ideal input source, however, simulation models may not account for all possible internal noise sources. Table 35 shows the simulation results for the 8V79S683 buffer with an ideal input source. Table 38 shows output phase noise measured with a low-noise input source, with one column for the measured data and a second column which de-rates the measured data by a factor to model the process variation. Table 38 shows that the input phase noise is the dominating factor in the measured data up to an offset of 100kHz. Above 100kHz, the noise floor of the device dominates the characteristics.

Table 35: Additive Clock Phase Noise Characteristics (Simulation<sup>a</sup>),  $V_{DD\ V}$  = 3.3V ± 5%<sup>b</sup>

| Symbol                | Parameter                     |           | Test Conditions                           | 25°C   | 85°C, Worst Case | Units  |
|-----------------------|-------------------------------|-----------|---|--------|------------------|--------|
| Φ <sub>N</sub> (1k)   |                               |           | 1kHz offset from Carrier                  | -146.2 | -145.5           | dBc/Hz |
| Φ <sub>N</sub> (10k)  | 1                             |           | 10kHz offset from Carrier                 | -156.6 | -155.3           | dBc/Hz |
| Φ <sub>N</sub> (100k) | 1                             | 245.76MHz | 100kHz offset from Carrier                | -161.9 | -159.6           | dBc/Hz |
| Φ <sub>N</sub> (1M)   | 1                             |           | 1MHz offset from Carrier                  | -162.4 | -160.5           | dBc/Hz |
| Φ <sub>N</sub> (10M)  | 1                             |           | 10MHz offset from Carrier and Noise Floor | -162.4 | -160.5           | dBc/Hz |
| Φ <sub>N</sub> (1k)   | 1                             |           | 1kHz offset from Carrier                  | -141.6 | -141.6           | dBc/Hz |
| Φ <sub>N</sub> (10k)  | 1                             |           | 10kHz offset from Carrier                 | -152.7 | -151.6           | dBc/Hz |
| Φ <sub>N</sub> (100k) | QCLK_ <i>y</i><br>Phase Noise | 491.52MHz | 100kHz offset from Carrier                | -159.2 | -157.0           | dBc/Hz |
| Φ <sub>N</sub> (1M)   | T Hadd Holds                  |           | 1MHz offset from Carrier                  | -159.8 | -158.1           | dBc/Hz |
| Φ <sub>N</sub> (10M)  | 1                             |           | 10MHz offset from Carrier and Noise Floor | -159.9 | -158.2           | dBc/Hz |
| Φ <sub>N</sub> (1k)   | 1                             |           | 1kHz offset from Carrier                  | -134.5 | -132.0           | dBc/Hz |
| Φ <sub>N</sub> (10k)  | 1                             |           | 10kHz offset from Carrier                 | -141.4 | -141.8           | dBc/Hz |
| Φ <sub>N</sub> (100k) | 1                             | 983.04MHz | 100kHz offset from Carrier                | -155.8 | -152.6           | dBc/Hz |
| Φ <sub>N</sub> (1M)   | 1                             |           | 1MHz offset from Carrier                  | -157.2 | -155.3           | dBc/Hz |
| Φ <sub>N</sub> (10M)  |                               |           | 10MHz offset from Carrier and Noise Floor | -157.2 | -155.8           | dBc/Hz |

a. Ideal input signal: rectangular clock signal with a slew rate of 5V/ns and without phase noise.

b. Phase noise and spurious specifications apply for device operation with QREF\_r outputs inactive (no SYSREF pulses generated). Phase noise specifications are applicable for all outputs active, Nx not equal, process and voltage variations included.



Figure 8: Additive Clock Phase Noise Characteristics (85°C, Worst Case Simulation Model)

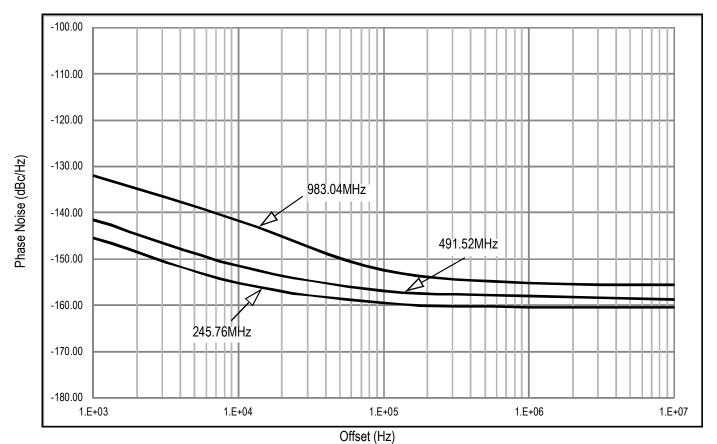




Table 36: Additive Clock Phase Noise Characteristics (Measured),  $V_{DD\ V}$  = 3.3V ± 5%,  $T_A$  = -40°C to +105°C<sup>a b</sup>

| Symbol                | Param                 | neter     | Test Conditions                           | Measured <sup>c</sup> | De-Rated <sup>d</sup> | Units  |
|-----------------------|-----------------------|-----------|---|-----------------------|-----------------------|--------|
| Φ <sub>N</sub> (1k)   |                       |           | 1kHz offset from Carrier                  | -141.4                | -137.2                | dBc/Hz |
| Φ <sub>N</sub> (10k)  | 1                     |           | 10kHz offset from Carrier                 | -151.7                | -149.5                | dBc/Hz |
| Φ <sub>N</sub> (100k) | -                     | 245.76MHz | 100kHz offset from Carrier                | -157.8                | -155.5                | dBc/Hz |
| Φ <sub>N</sub> (1M)   | -                     |           | 1MHz offset from Carrier                  | -158.6                | -156.2                | dBc/Hz |
| Φ <sub>N</sub> (10M)  | -                     |           | 10MHz offset from Carrier and Noise Floor | -158.8                | -156.3                | dBc/Hz |
| Φ <sub>N</sub> (1k)   | -                     |           | 1kHz offset from Carrier                  | -135.3                | -128.4                | dBc/Hz |
| Φ <sub>N</sub> (10k)  | 1                     |           | 10kHz offset from Carrier                 | -145.8                | -140.5                | dBc/Hz |
| Φ <sub>N</sub> (100k) | QCLK_y<br>Phase Noise | 491.52MHz | 100kHz offset from Carrier                | -154.2                | -149.5                | dBc/Hz |
| Φ <sub>N</sub> (1M)   | 1 1100 110100         |           | 1MHz offset from Carrier                  | -157.2                | -155.4                | dBc/Hz |
| Φ <sub>N</sub> (10M)  | -                     |           | 10MHz offset from Carrier and Noise Floor | -157.6                | -156.3                | dBc/Hz |
| Φ <sub>N</sub> (1k)   | -                     |           | 1kHz offset from Carrier                  | -131.3                | -125.7                | dBc/Hz |
| Φ <sub>N</sub> (10k)  | -                     |           | 10kHz offset from Carrier                 | -141.2                | -138.5                | dBc/Hz |
| Φ <sub>N</sub> (100k) | -                     | 983.04MHz | 100kHz offset from Carrier                | -149.6                | -146.5                | dBc/Hz |
| Φ <sub>N</sub> (1M)   | -                     |           | 1MHz offset from Carrier                  | -154.5                | -152.2                | dBc/Hz |
| Φ <sub>N</sub> (10M)  | 1                     |           | 10MHz offset from Carrier and Noise Floor | -155.3                | -152.5                | dBc/Hz |
| fiit(Q\)              | Clock RMS Pha         | se Jitter | Integration Range: 1kHz - 61.44MHz        |                       | 100                   | fs     |
| <i>t</i> jit(Ø)       | (Random)              |           | Integration Range: 12kHz - 20MHz          |                       | 100                   | fs     |

- a. Phase noise and spurious specifications apply for device operation with QREF\_r outputs inactive (no SYSREF pulses generated). Phase noise specifications are applicable for all outputs active, Nx not equal.
- b. Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.
- c. Measured results at the max. temperature of 85°C using an input source with a phase noise characteristics of:
  - 245.76MHz: -143.7dBc/Hz (1kHz offset), -152.5dBc/Hz (10kHz), -160.8dBc/Hz (100kHz), -172.6dBc/Hz (1MHz), -179.5dBc/Hz (10MHz).
  - 491.52MHz: -137.7dBc/Hz (1kHz offset), -147.4dBc/Hz (10kHz), -156.1dBc/Hz (100kHz), -167.6dBc/Hz (1MHz), -170.1dBc/Hz (10MHz).
  - 983.04MHz: -132.5dBc/Hz (1kHz offset), -141.4dBc/Hz (10kHz), -149.9dBc/Hz (100kHz), -161.4dBc/Hz (1MHz), -164.2dBc/Hz (10MHz).
- d. De-rating factor applied to the characterized data at 85°C to account for worst-case process variation.



Figure 9: Additive Clock Phase Noise Characteristics (Measured),  $f_{OUT} = 245.76 MHz$ 

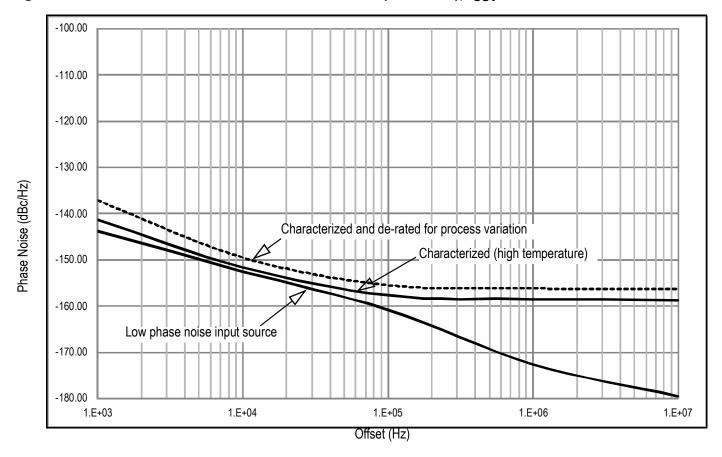




Figure 10: Additive Clock Phase Noise Characteristics (Measured),  $f_{OUT} = 491.52 MHz$ 

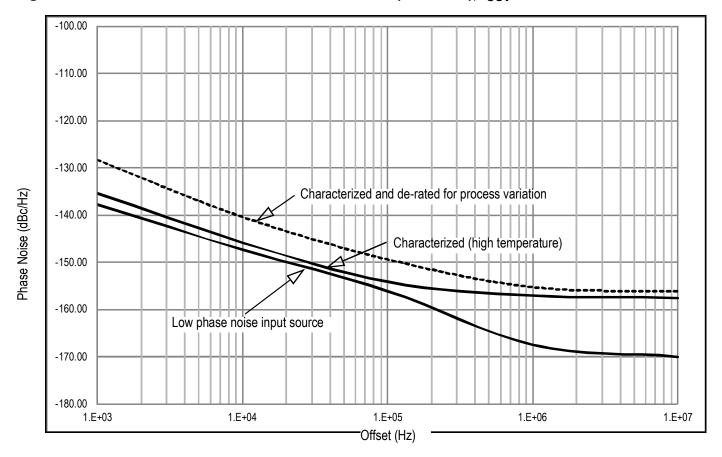
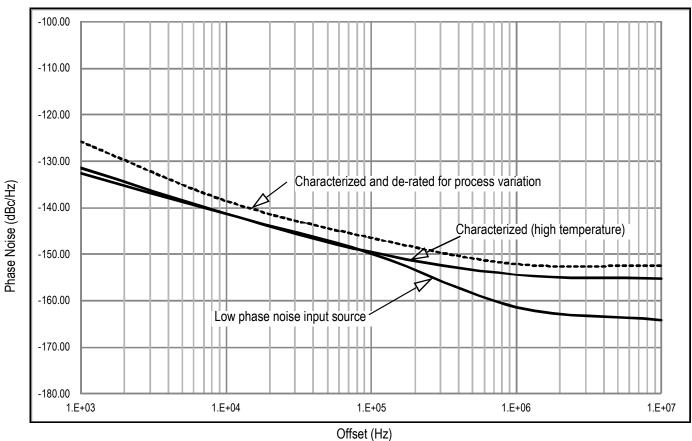




Figure 11: Additive Clock Phase Noise Characteristics (Measured),  $f_{OUT} = 983.04 MHz$ 



| Symbol                | Parameter   |                       | Test Conditions            | Typical | Units  |
|-----------------------|-------------|-----------------------|----------------------------|---------|--------|
| Ф <sub>N</sub> (1k)   |             |                       | 1kHz offset from Carrier   | -146    | dBc/Hz |
| Ф <sub>N</sub> (10k)  |             | 45 2CM11=8            | 10kHz offset from Carrier  | -152.5  | dBc/Hz |
| Ф <sub>N</sub> (100k) |             | 15.36MHz <sup>a</sup> | 100kHz offset from Carrier | -156    | dBc/Hz |
| Φ <sub>N</sub> (1M)   | QREF_r      |                       | 1MHz offset from Carrier   | -156    | dBc/Hz |
| Ф <sub>N</sub> (1k)   | Phase Noise |                       | 1kHz offset from Carrier   | -147.5  | dBc/Hz |
| Ф <sub>N</sub> (10k)  | 20.7014     | 30.72MHz <sup>c</sup> | 10kHz offset from Carrier  | -153.5  | dBc/Hz |
| Ф <sub>N</sub> (100k) |             | JU.12IVIMZ            | 100kHz offset from Carrier | -155.5  | dBc/Hz |
| Φ <sub>N</sub> (1M)   | 1           |                       | 1MHz offset from Carrier   | -155.5  | dBc/Hz |

a. Measured results with DLC[1:0] = 00 and  $\Phi$ REF\_r = 3.



# **Application Information**

### **Input Interface Circuits**

Figure 12: LVDS Output Drives 8V79S683 Input with Integrated Termination Resistor (DC-Coupled)

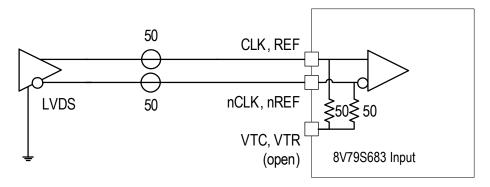
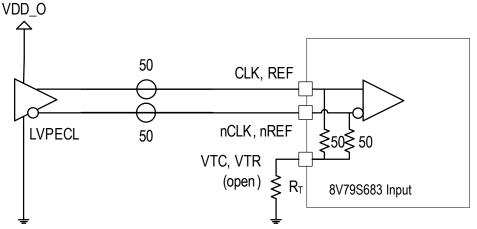


Figure 13: LVPECL Output Drives 8V79S683 Input with Integrated Termination Resistor (DC-Coupled)



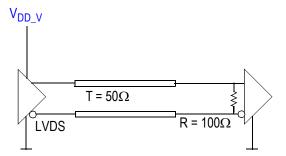
**Table 37: Termination Resistors** 

|                | V <sub>DD_O</sub> = 2.5V | V <sub>DD_O</sub> = 3.3V |
|----------------|--------------------------|--------------------------|
| R <sub>T</sub> | 18Ω                      | $50\Omega$               |

### Termination for QCLK\_y, QREF\_r LVDS Outputs (STYLE = 0)

Figure 14 shows an example termination for the QCLK\_y, QREF\_r LVDS outputs. In this example, the characteristic transmission line impedance is  $50\Omega$ . The termination resistor R ( $100\Omega$ ) is matched to the line impedance. The termination resistor must be placed at the line end. No external termination resistor is required if R is an internal part of the receiver circuit. The LVDS termination in Figure 14 is applicable for any output amplitude setting specified in Table 9.

Figure 14: LVDS (STYLE = 0) Output Termination





### AC Termination for QCLK\_y, QREF\_r LVDS Outputs (STYLE = 0)

Figure 15 and Figure 16 show example AC terminations for the QCLK\_y, QREF\_r LVDS outputs. In the examples, the characteristic transmission line impedance is  $50\Omega$ . In Figure 15, the termination resistor R ( $100\Omega$ ) is placed at the line end. No external termination resistor is required if R is an internal part of the receiver circuit, which is shown in Figure 16. The LVDS terminations in both Figure 15 and Figure 16 are applicable for any output amplitude setting specified in Table 9. The receiver input should be re-biased according to its common mode range specifications.

Figure 15: LVDS (STYLE = 0) AC Output Termination

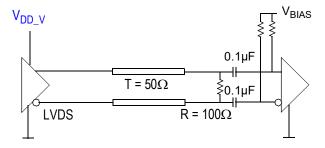
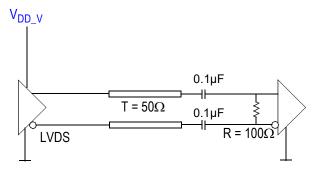


Figure 16: LVDS (STYLE = 0) AC Output Termination



### Termination for QCLK\_y, QREF\_r LVPECL Outputs (STYLE = 1)

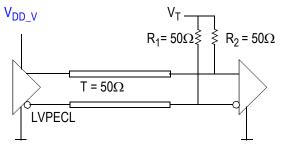
Figure 17 shows an example termination for the QCLK\_y, QREF\_rLVPECL outputs. In this example, the characteristic transmission line impedance is  $50\Omega$ . The R1 ( $50\Omega$ ) and R2 ( $50\Omega$ ) resistors are matched load terminations. The output is terminated to the termination voltage V<sub>T</sub>. The V<sub>T</sub> must be set according to the output amplitude setting defined in Table 9. The termination resistors must be placed close at the line end.

### Figure 17: LVPECL (STYLE = 1) Output Termination

 $V_T = V_{DD_V} - 1.60V$  (350 mV Amplitude)

 $V_T = V_{DD_V} - 2.00V (750 \text{ mV Amplitude})$ 

 $V_T = V_{DD_V} - 2.25V (1000mV Amplitude)$ 



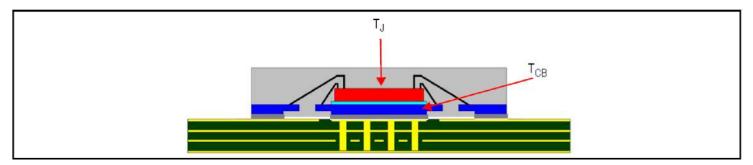


### **Package Exposed Pad Thermal Release Path**

In order to maximize both the removal of heat from the package and the electrical performance, a land pattern must be incorporated on the Printed Circuit Board (PCB) within the footprint of the package corresponding to the exposed metal pad or exposed heat slug on the package, as shown in Figure 18. The solderable area on the PCB, as defined by the solder mask, should be at least the same size/shape as the exposed pad/slug area on the package to maximize the thermal/electrical performance. Sufficient clearance should be designed on the PCB between the outer edges of the land pattern and the inner edges of pad pattern for the leads to avoid any shorts.

While the land pattern on the PCB provides a means of heat transfer and electrical grounding from the package to the board through a solder joint, thermal vias are necessary to effectively conduct from the surface of the PCB to the ground plane(s). The land pattern must be connected to ground through these vias. The vias act as "heat pipes". The number of vias (i.e. "heat pipes") are application specific and dependent upon the package power dissipation as well as electrical conductivity requirements. Thus, thermal and electrical analysis and/or testing are recommended to determine the minimum number needed. Maximum thermal and electrical performance is achieved when an array of vias is incorporated in the land pattern. It is recommended to use as many vias connected to ground as possible. It is also recommended that the via diameter should be 12 to 13mils (0.30 to 0.33mm) with 1oz copper via barrel plating. This is desirable to avoid any solder wicking inside the via during the soldering process which may result in voids in solder between the exposed pad/slug and the thermal land. Precautions should be taken to eliminate any solder voids between the exposed heat slug and the land pattern. Note: These recommendations are to be used as a guideline only. For further information, refer to the Application Note on the Surface Mount Assembly of Amkor's Thermally/Electrically Enhance Lead-frame Base Package, Amkor Technology.

Figure 18: Assembly for Exposed Pad Thermal Release Path - Side View (drawing not to scale)





### **Thermal Characteristics**

Table 38: Thermal Resistance for 64-VFQFPN Package<sup>a</sup>

| Symbol            | Thermal Parameter   | Condition      | Value | Unit |
|-------------------|---------------------|----------------|-------|------|
|                   |                     | 0 m/s air flow | 22.76 | °C/W |
|                   |                     | 1 m/s air flow | 19.25 | °C/W |
| 0                 | Junction to ambient | 2 m/s air flow | 17.70 | °C/W |
| $\Theta_{JA}$     | Junction to ambient | 3 m/s air flow | 16.87 | °C/W |
|                   |                     | 4 m/s air flow | 16.37 | °C/W |
|                   |                     | 5 m/s air flow | 16.03 | °C/W |
| $\Theta_{\sf JC}$ | Junction to case    |                | 14.33 | °C/W |
| $\Theta_{JB}$     | Junction to board   |                | 1.1   | °C/W |

a. Standard JEDEC 2S2P multilayer PCB.

### **Case Temperature Considerations**

This device supports applications in a natural convection environment which does not have any thermal conductivity through ambient air. The printed circuit board (PCB) is typically in a sealed enclosure without any natural or forced air flow and is kept at or below a specific temperature. The device package design incorporates an exposed pad (ePad) with enhanced thermal parameters which is soldered to the PCB where most of the heat escapes from the bottom exposed pad. For this type of application, it is recommended to use the junction-to-board thermal characterization parameter  $\Psi_{JB}$  (Psi-JB) to calculate the junction temperature ( $T_J$ ) and ensure it does not exceed the maximum allowed operating junction temperature in the Absolute Maximum Rating table.

The junction-to-board thermal characterization parameter,  $\Psi_{JB}$  is calculated using the following equation:

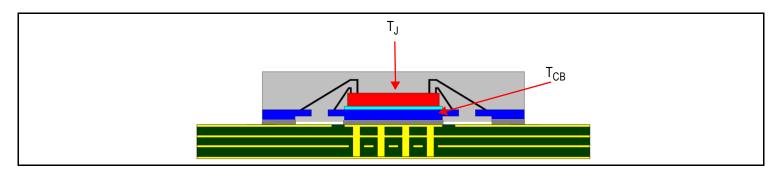
$$T_J = T_{CB} + \Psi_{JB} \times P_{D.}$$
 where:

T<sub>J</sub> = Junction temperature at steady state condition in (°C)

T<sub>CB</sub> = Case temperature (Bottom) at steady state condition in (°C)

 $\Psi_{JB}$  = Thermal characterization parameter to report the difference between junction temperature and the temperature of the board measured at the top surface of the board

 $P_D$  = power dissipation (W) in desired operating configuration



The ePad provides a low thermal resistance path for heat transfer to the PCB and represents the key pathway to transfer heat away from the IC to the PCB. It's critical that the connection of the exposed pad to the PCB is properly constructed to maintain the desired IC case temperature ( $T_{CB}$ ). A good connection ensures that temperature at the exposed pad ( $T_{CB}$ ) and the board temperature ( $T_{CB}$ ) are relatively the same. An improper connection can lead to increased junction temperature, increased power consumption and decreased electrical performance. In addition, there could be long-term reliability issues and increased failure rate.



# Example Calculation for Junction Temperature (T<sub>J</sub>): T<sub>J</sub> = T<sub>CB</sub> + $\Psi$ <sub>JB</sub> x P<sub>D</sub> Table 39: Thermal Resistance for 64-VFQFPN package<sup>a</sup>

| Package type    | 64-VFQFPN          |
|-----------------|--------------------|
| Body size (mm)  | 9 × 9 × 0.85 mm    |
| ePad size (mm)  | 6.00 × 6.00 mm     |
| Thermal Via     | 8 × 8 Matrix       |
| $\Psi_{JB}$     | 1.1 C/W            |
| T <sub>CB</sub> | 105°C              |
| $P_{D}$         | 2.76W <sup>b</sup> |

- a. Standard JEDEC 2S2P multilayer PCB.
- b. See Table 27, test case 6.

For the variables above, the junction temperature is  $T_J = T_{CB} + \Psi_{JB} \times P_D = 105^{\circ}C + 1.1^{\circ}C/W \times 2.76W = 108^{\circ}C$ . Since this operating junction temperature is below the maximum operating junction temperature of 125°C, there are no long term reliability concerns. In addition, since the junction temperature at which the device was characterized using forced convection is 108.6°C, this device can function without the degradation of the specified AC or DC parameters.

## **Package Outline Drawings**

The package outline drawings are located at the end of this document and are accessible from the Renesas website (see Ordering Information for POD links). The package information is the most current data available and is subject to change without revision of this document.

# **Marking Diagram**



● LOT COO

- Line 1 indicates the manufacturer.
- Line 2 indicates the part number.
- Line 3 indicates the following:
  - "#" denotes stepping.
  - "YY" is the last two digits of the year; "WW" is the work week number when the part was assembled.



# **Ordering Information**

| Orderable Part Number | Package            | MSL Rating | Shipping Packaging                               | Temperature    |
|-----------------------|--------------------|------------|--|----------------|
| 8V79S683NLGI          |                    | 3          | Tray   |                |
| 8V79S683NLGI8         | RoHS 6/6 64-VFQFPN | 3          | Tape and Reel, Pin 1<br>Orientation: EIA-481-C   | -40°C to +85°C |
| 8V79S683NLGI/W        |                    | 3          | Tape and Reel, Pin 1<br>Orientation: EIA-481-D/E |                |

### Table 40: Pin 1 Orientation in Tape and Reel Packaging

| Part Number Suffix | Pin 1 Orientation        | Illustration  |  |  |
|--------------------|--------------------------|---|--|--|
| 8                  | Quadrant 1 (EIA-481-C)   | Connect FIN 1 OFFICE (Round Sprocker Hotes)  USER DIRECTION OF FEED |  |  |
| /W                 | Quadrant 2 (EIA-481-D/E) | CARRIER TAPE TOPSIDE (Round Sprocker Holes)  USER DIRECTION OF FEED |  |  |



# Glossary

| Abbreviation      | Description  |  |
|-------------------|--|--|
| Index x           | Denominates a channel, channel frequency divider and the associated configuration bits. Range: A, B, C, D.   |  |
| Index y           | Denominates a QCLK output and associated configuration bits. Range: A0, A1, A2, B0, B1, C0, C1, D.   |  |
| Index r           | Denominates a QREF output and associated configuration bits. Range: A0, A1, A2, B0, B1, C0, C1, D.   |  |
| V <sub>DD_V</sub> | Denominates voltage supply pins. Range: V <sub>DD_QCLKA</sub> , V <sub>DD_QREFA01</sub> , V <sub>DD_QREFA2</sub> , V <sub>DD_QCLKB</sub> , V <sub>DD_QREFB</sub> , V <sub>DD_QCLKD</sub> , V <sub>DD_QCLKD</sub> , V <sub>DD_QCLKD</sub> , V <sub>DD_QCLKD</sub> , V <sub>DD_QREFD</sub> , V <sub>DD_CLK</sub> , V <sub>DD_REF</sub> . |  |
| []                | Index brackets describe a group associated with a logical function or a bank of outputs.   |  |
| {}                | List of discrete values.   |  |

# **Revision History**

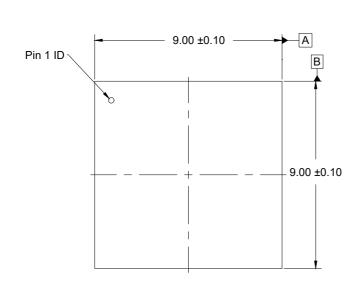
| Date               | Description of Change                            |
|--------------------|--|
| September 13, 2021 | Updated V <sub>CMR</sub> minimum voltage to '1'. |
| July 18, 2019      | Initial release.                                 |

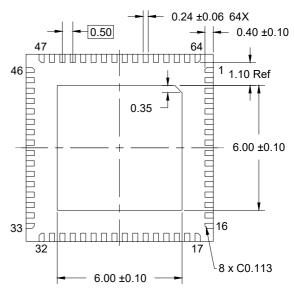




Package Code: NLG64P5 64-VFQFPN 9.0 x 9.0 x 0.9 mm Body, 0.50mm Pitch

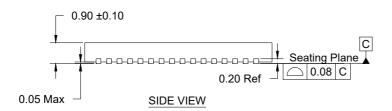
PSC-4147-05, Revision: 06, Date Created: Aug 07, 2023

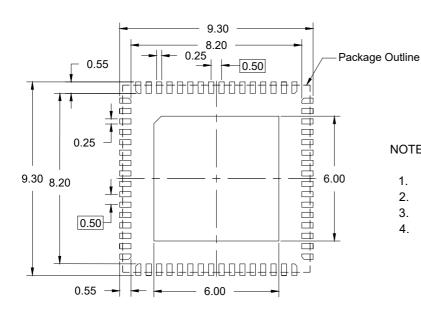




#### TOP VIEW

### **BOTTOM VIEW**





#### NOTES:

- JEDEC compatible. 1.
- All dimensions are in mm and angles are in degrees.
- Use ±0.05 mm for the non-toleranced dimensions.
- Numbers in ( ) are for references only.

RECOMMENDED LAND PATTERN (PCB Top View, NSMD Design)

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